



Trion[®] Packaging User Guide

UG-TRION-PKG-v4.9

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Introduction

Efinix offers Trion® FPGAs in packages that are designed for the devices' maximum number of user's I/O pins. This document describes the Trion® FPGAs' pin and package specifications as well as solder reflow guidelines.



Learn more: Refer to the following documents for more information:

FPGA pinout specification

FPGA data sheet for pin definitions

Available Package Options

Table 1: Available Packages

Package	Dimensions (mm x mm)	Pitch (mm)
T4/T8 FPGAs		
49-ball FBGA ⁽¹⁾	3 x 3	0.4
81-ball FBGA	5 x 5	0.5
T20 FPGAs		
80-ball WLCSP	4.5 x 3.6	0.4
T8/T20 FPGAs		
144-pin LQFP	20 x 20	0.5
T13/T20 FPGAs		
100-pin LQFP	14 x 14	0.5
169-ball FBGA	9 x 9	0.65
256-ball FBGA	13 x 13	0.8
T20/T35 FPGAs		
324-ball FBGA	12 x 12	0.65
400-ball FBGA	16 x 16	0.8
T55/T85/T120 FPGAs		
324-ball FBGA	12 x 12	0.65
484-ball FBGA	18 x 18	0.80
576-ball FBGA	16 x 16	0.65

Refer to the FPGA data sheet for information on the number of GPIO and other resources in each FPGA/package combination.

⁽¹⁾ This package does not have dedicated JTAG pins (TDI, TDO, TCK, TMS).

Device Pinout File

Efinix provides pinout files for Trion® FPGAs. For each device/package combination, these files contain the pin name, I/O bank number for each pin, configuration function, and pin location.



Download: Download the pinout files from the Documentation page in the Support section of the Efinix® web site (www.efinixinc.com/support)

Pinout Description

The following tables describe the pinouts for power, ground, configuration, and interfaces.

Table 2: General Pinouts

Function	Group	Direction	Description
VCC	Power	-	Core power supply.
VCCA_xx	Power	-	PLL analog power supply. xx indicates the location.
VCCIOxx	Power	-	I/O pin power supply. xx indicates the bank location.
VCCIOxx_yy_zz	Power	-	I/O pin power supply. Power for I/O banks that are shorted together. xx, yy, and zz are the bank locations.
GND	Ground	-	Ground.
CLKn	Alternate	Input	Global clock network input. n is the number. The number of inputs is package dependent.
CTRLn	Alternate	Input	Global network input used for high fanout and global reset. n is the number. The number of inputs is package dependent.
PLLIN	Alternate	Input	PLL reference clock.
GNDA_PLL	Ground	-	PLL ground pin.
MREFCLK	Alternate	Input	MIPI PLL reference clock source.
GPIOx_n	GPIO	I/O	General-purpose I/O for user function. User I/O pins are single-ended. x: Indicates the bank (L or R) n: Indicates the GPIO number.
GPIOx_n_yyy GPIOx_n_yyy_zzz GPIOx_zzzn	GPIO Multi-Function	I/O	Multi-function, general-purpose I/O. These pins are single ended. If these pins are not used for their alternate function, you can use them as user I/O pins. x: (T4) Indicates the bank; left (L) or right (R). x: (T13/T20) Indicates the bank; left (L), right (R), or bottom (B). n: Indicates the GPIO number. yyy, yyy_zzz: Indicates the alternate function. zzzn: Indicates LVDS TX or RX and number.
TXNn, TXPn	LVDS	I/O	LVDS transmitter (TX). n: Indicates the number.
RXNn, RXPn	LVDS	I/O	LVDS receiver (RX). n: Indicates the number.
CLKNn, CLKPn	LVDS	I/O	Dedicated LVDS receiver clock input. n: Indicates the number.

Function	Group	Direction	Description
RXNn_EXTFBn RXPn_EXTFBn	LVDS	I/O	LVDS PLL external feedback. <i>n</i> : Indicates the number.
REF_RES	-	-	REF_RES is a reference resistor to generate constant current for LVDS TX. Connect a 12 kΩ resistor with a tolerance of ±1% to the REF_RES pin with respect to ground. If none of the pins in a bank are used for LVDS, leave this pin floating.

Table 3: Dedicated Configuration Pins

These pins cannot be used as general-purpose I/O after configuration.

Pins	Direction	Description	Use External Weak Pull-Up
CDONE	I/O	Configuration done status pin. CDONE is an open drain output; connect it to an external pull-up resistor to VCCIO. When CDONE = 1, the configuration is complete. If you hold CDONE low, the device will not enter user mode.	✓
CRESET_N	Input	Initiates FPGA re-configuration (active low). Pulse CRESET_N low for a duration of t_{creset_N} before asserting CRESET_N from low to high to initiate FPGA re-configuration. This pin does not perform a system reset.	✓
TCK	Input	JTAG test clock input (TCK). The rising edge loads signals applied at the TAP input pins (TMS and TDI). The falling edge clocks out signals through the TAP TDO pin.	✓
TMS	Input	JTAG test mode select input (TMS). The I/O sequence on this input controls the test logic operation . The signal value typically changes on the falling edge of TCK. TMS has an internal weak pull-up; when it is not driven by an external source, the test logic perceives a logic 1.	Recommended
TDI	Input	JTAG test data input (TDI). Data applied at this serial input is fed into the instruction register or into a test data register depending on the sequence previously applied at TMS. Typically, the signal applied at TDI changes state following the falling edge of TCK while the registers shift in the value received on the rising edge. Like TMS, TDI has an internal weak pull-up; when it is not driven from an external source, the test logic perceives a logic 1.	Recommended
TDO	Output	JTAG test data output (TDO). This serial output from the test logic is fed from the instruction register or from a test data register depending on the sequence previously applied at TMS. During shifting, data applied at TDI appears at TDO after a number of cycles of TCK determined by the length of the register included in the serial path. The signal driven through TDO changes state following the falling edge of TCK. When data is not being shifted through the device, TDO is set to an inactive drive state (e.g., high-impedance).	✓



Note: All dedicated configuration pins have Schmitt Trigger buffer. Refer to the respective Trion FPGAs [datasheet](#) for the Schmitt Trigger buffer specifications in **Single Ended I/O and Dedicated Configuration Pins Schmitt Trigger Buffer** table.

Table 4: Dual-Purpose Configuration Pins

In user mode (after configuration), you can use these dual-purpose pins as general I/O.

Pins	Direction	Description	Use External Weak Pull-Up
CBUS[2:0]	Input	Configuration bus width select. CBUS has an internal weak pull-up. However, Efinix recommends that you use an external pull-up accordingly. See <i>Selecting the Configuration Mode in AN 006: Configuring Trion FPGAs</i>	✓ ⁽²⁾
CBSEL[1:0]	Input	Optional multi-image selection input (if external multi-image configuration mode is enabled).	✓ ⁽³⁾
CCK	I/O	Passive SPI input configuration clock or active SPI output configuration clock (active low). Includes an internal weak pull-up. ! Important: The CCK pin in Q100F3 packages are only available in user mode when the LVDS TX resources are not in use. The CCK pin should not be toggled when any LVDS TX is used.	Optional ⁽⁴⁾
CDIn	I/O	n is a number from 0 to 31 depending on the SPI configuration. 0: Passive serial data input or active serial output. 1: Passive serial data output or active serial input. n : Parallel I/O. In multi-bit daisy chain connection, the CDIn (31:0) connects to the data bus in parallel.	Optional ⁽⁴⁾
CSI	Input	Chip select. 0: The FPGA is not selected or enabled and will not be configured. 1: Selects the FPGA for configuration (SPI and JTAG configuration).	✓
CSO	Output	Chip select output. Selects the next device for cascading configuration.	N/A
NSTATUS	Output	Status (active low). Indicates a configuration error. When the FPGA drives this pin low, it indicates an ID mismatch, the bitstream CRC check has failed, or remote update has failed. For Trion® T4, T8 BGA49, and T8 BGA81 FPGAs, logic low indicates a configuration error due to ID mismatch.	N/A
SS_N	Input	SPI slave select (active low). Includes an internal weak pull-up resistor to VCCIO during configuration. During configuration, the logic level samples on this pin determine the configuration mode. This pin is an input when sampled at the start of configuration (SS is low); an output in active SPI flash configuration mode. The FPGA senses the value of SS_N when it comes out of reset (pulse CRESET_N low to high). 0: Passive mode 1: Active mode	Optional ⁽⁴⁾

⁽²⁾ Optional for x1 mode.

⁽³⁾ Not applicable to single-image or remote update.

⁽⁴⁾ Optional unless pull-up is required by external load.

Pins	Direction	Description	Use External Weak Pull-Up
TEST_N	Input	Active-low test mode enable signal. Set to 1 to disable test mode. During configuration, rely on the external weak pull-up or drive this pin high.	✓
RESERVED_OUT	Output	Reserved pin during user configuration. This pin drives high during user configuration. BGA49 and BGA81 packages only.	N/A

Table 5: MIPI Pinouts (Dedicated)*n* Indicates the number. *L* indicates the lane

Function	Group	Direction	Description
VCC25A_MIPI0	Power	-	MIPI 2.5 V analog power supply.
VCC25A_MIPI1			
VCC12A_MIPI0_TX	Power	-	MIPI 1.2 V TX analog power supply.
VCC12A_MIPI1_TX			
VCC12A_MIPI0_RX	Power	-	MIPI 1.2 V RX analog power supply.
VCC12A_MIPI1_RX			
GNDA_MIPI	Ground	-	Ground for MIPI analog power supply.
MIPIIn_RXDPL	MIPI	I/O	MIPI differential transmit data lane.
MIPIIn_RXDNL			
MIPIIn_RXDPL	MIPI	I/O	MIPI differential receive data lane.
MIPIIn_RXDNL			
MREFCLK	Clock	Input	MIPI PLL reference clock source.

Table 6: DDR Pinouts (Dedicated)

n indicates the number.

Function	Direction	Description
VCCIO_DDR	-	DDR power supply.
DDR_A[n]	Output	Address signals to the memories.
DDR_BA[n]	Output	Bank signals to the memories.
DDR_CAS_N	Output	Active-low column address strobe signal to the memories.
DDR_CKE	Output	Active-high clock enable signals to the memories.
DDR_CK	Output	Differential clock output pins to the memories.
DDR_CK_N		
DDR_CS_N	Output	Active-low chip select signals to the memories.
DDR_DQ[n]	I/O	Data bus to/from the memories.
DDR_DM[n]	Output	Active-high data-mask signals to the memories.
DDR_DQS_N[n]	I/O	Differential data strobes to/from the memories.
DDR_DQS[n]	I/O	Differential data strobes to/from the memories.
DDR_ODT	Output	ODT signal to the memories.
DDR_RAS_N	Output	Active-low row address strobe signal to the memories.
DDR_RST_N	Output	Active-low reset signals to the memories.
DDR_WE_N	Output	Active-low write enable strobe signal to the memories.
DDR_VREF	I/O	Reference voltage.
DDR_ZQ	I/O	ZQ calibration pin.

Table 7: SPI Flash Memory Pin

Function	Direction	Description
SPI_CS_N	Input	Internal SPI flash memory chip select. Available in QFP100F3 packages only.

49-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 1: 49-Ball FBGA Pinout Diagram

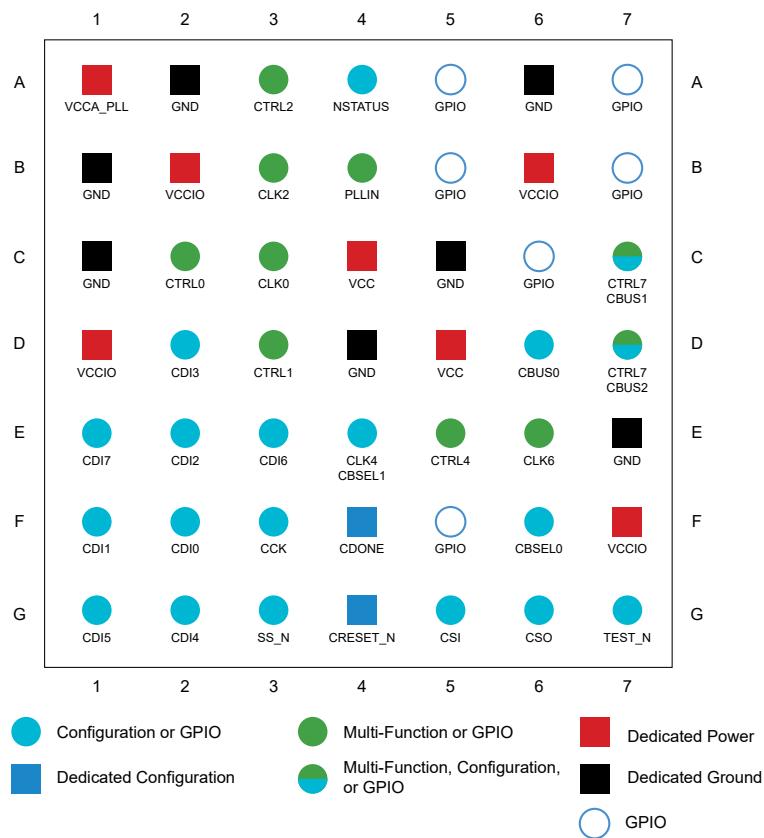


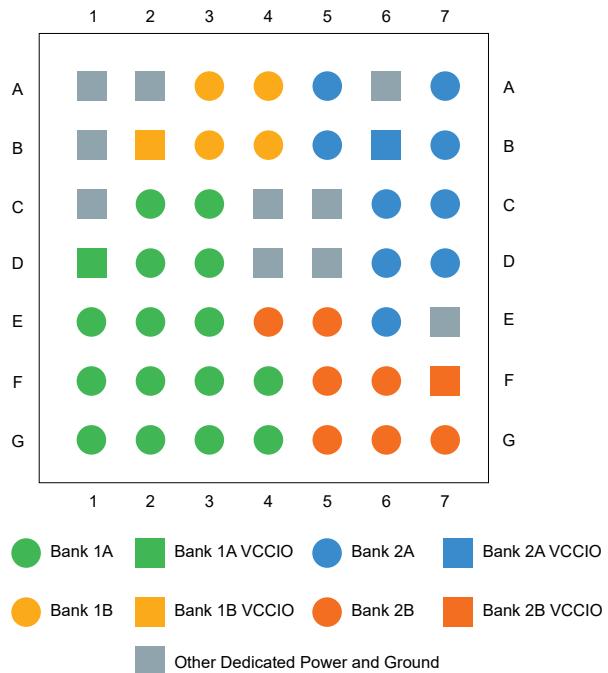
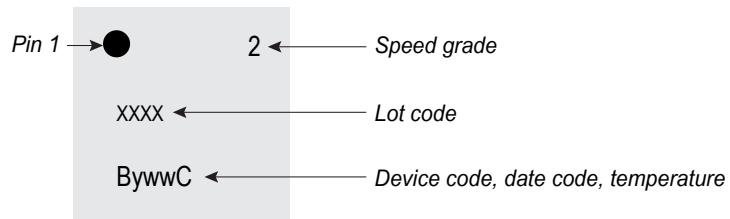
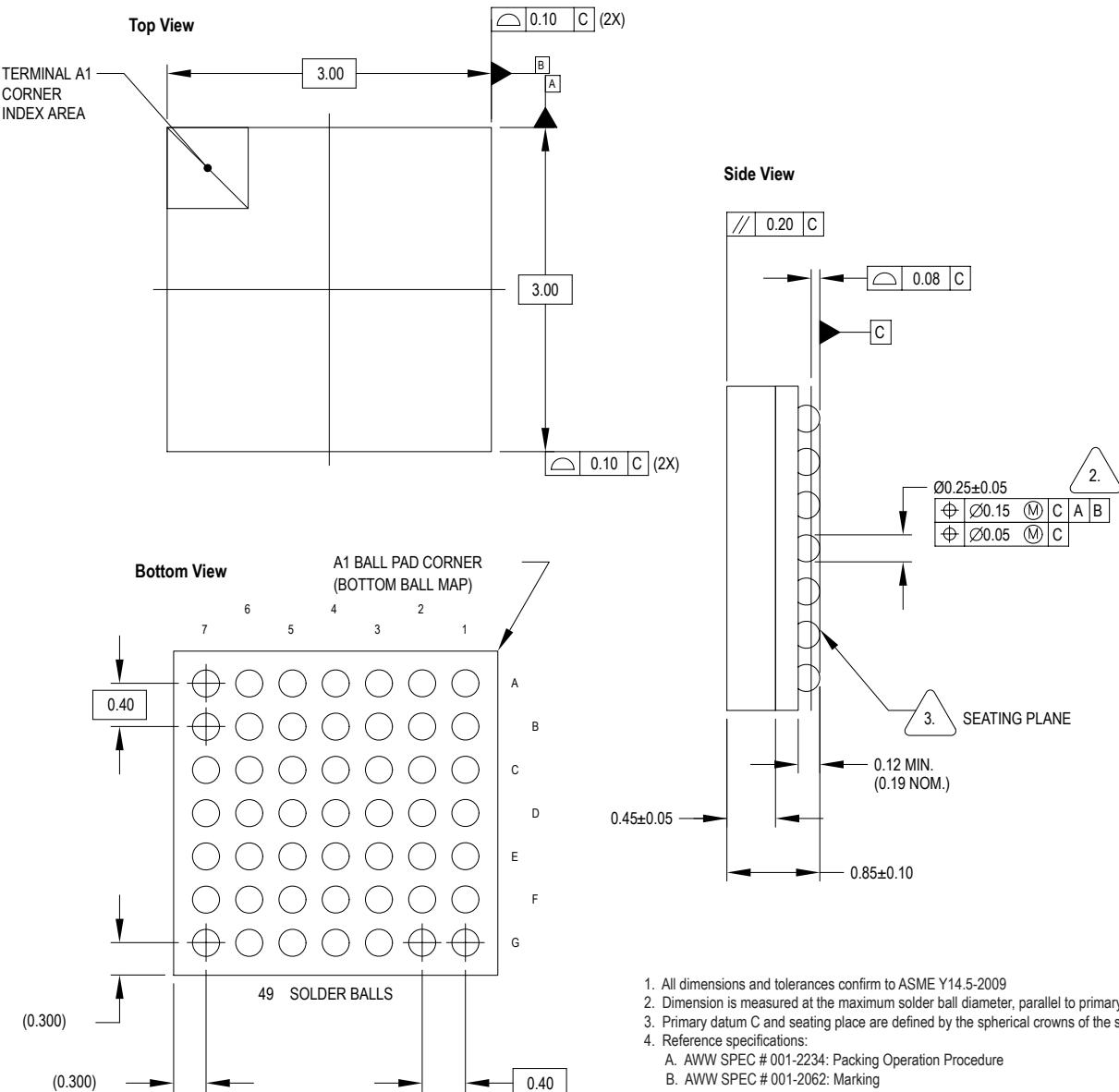
Figure 2: 49-Ball FBGA I/O Bank Diagram**Figure 3: 49-Ball FPGA Package Marking**

Figure 4: 49-Ball FBGA Package Outline



80-Ball WLCSP Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 5: 80-Ball WLCSP Pinout Diagram

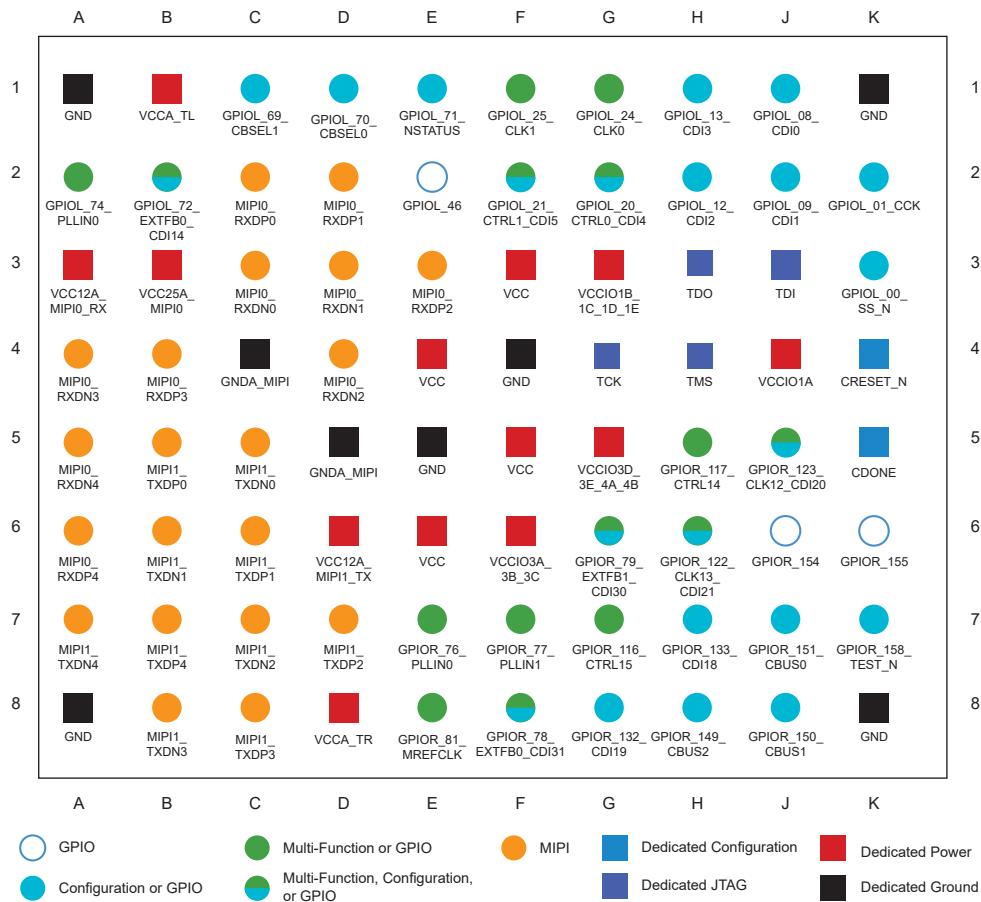


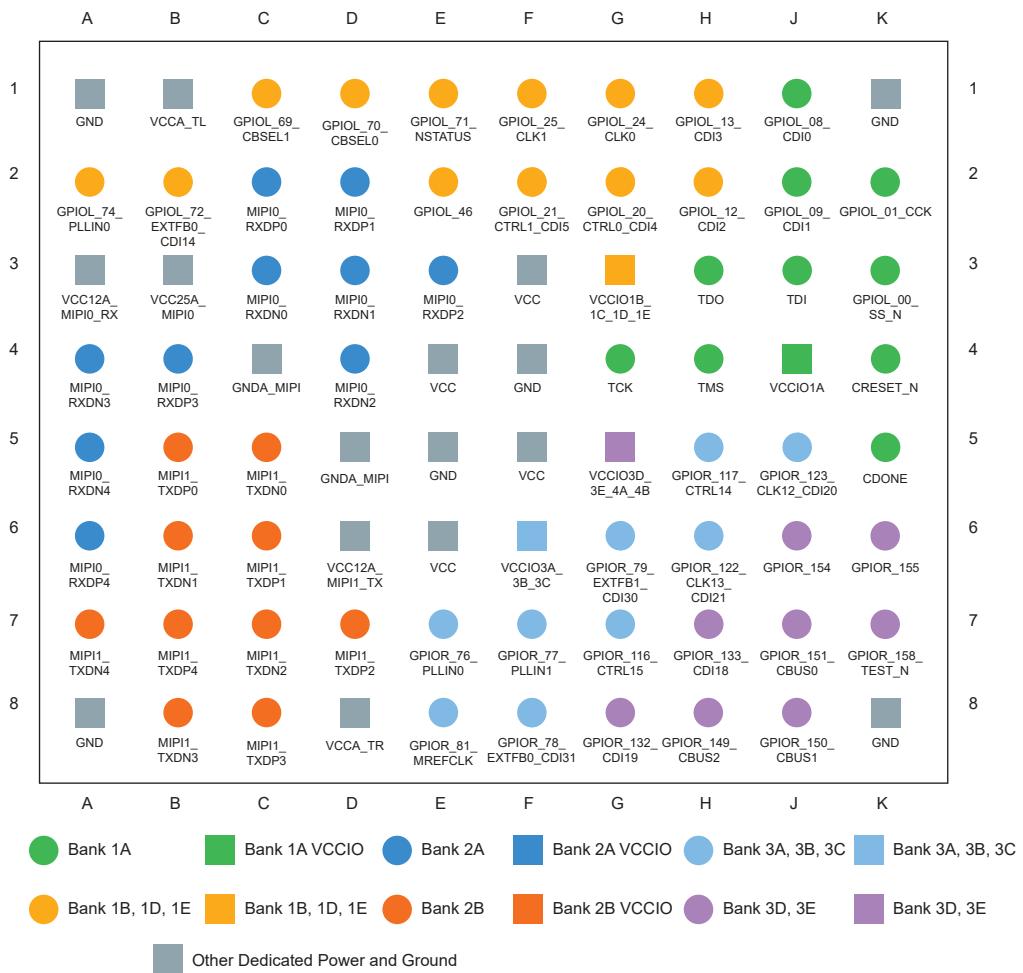
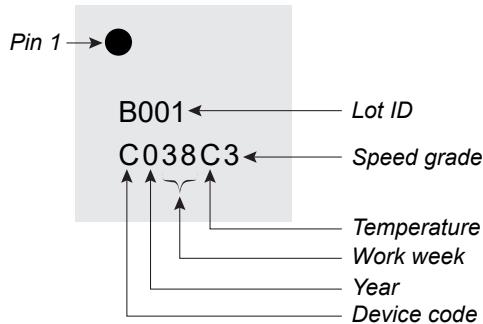
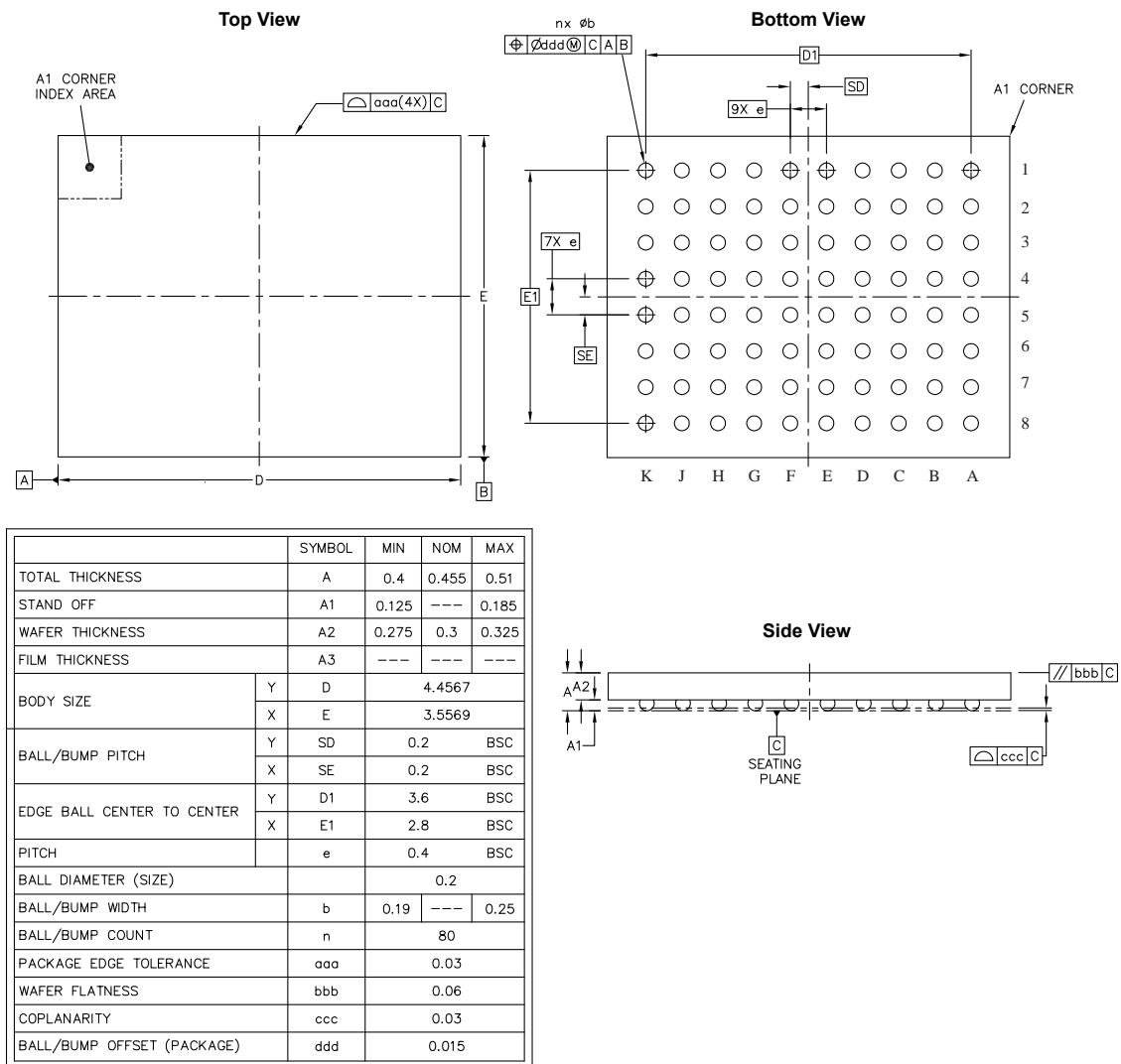
Figure 6: 80-Ball WLCSP I/O Bank Diagram**Figure 7: 80-Ball WLCSP Package Marking**

Figure 8: 80-Ball WLCSP Package Outline



81-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 9: 81-Ball FBGA Pinout Diagram

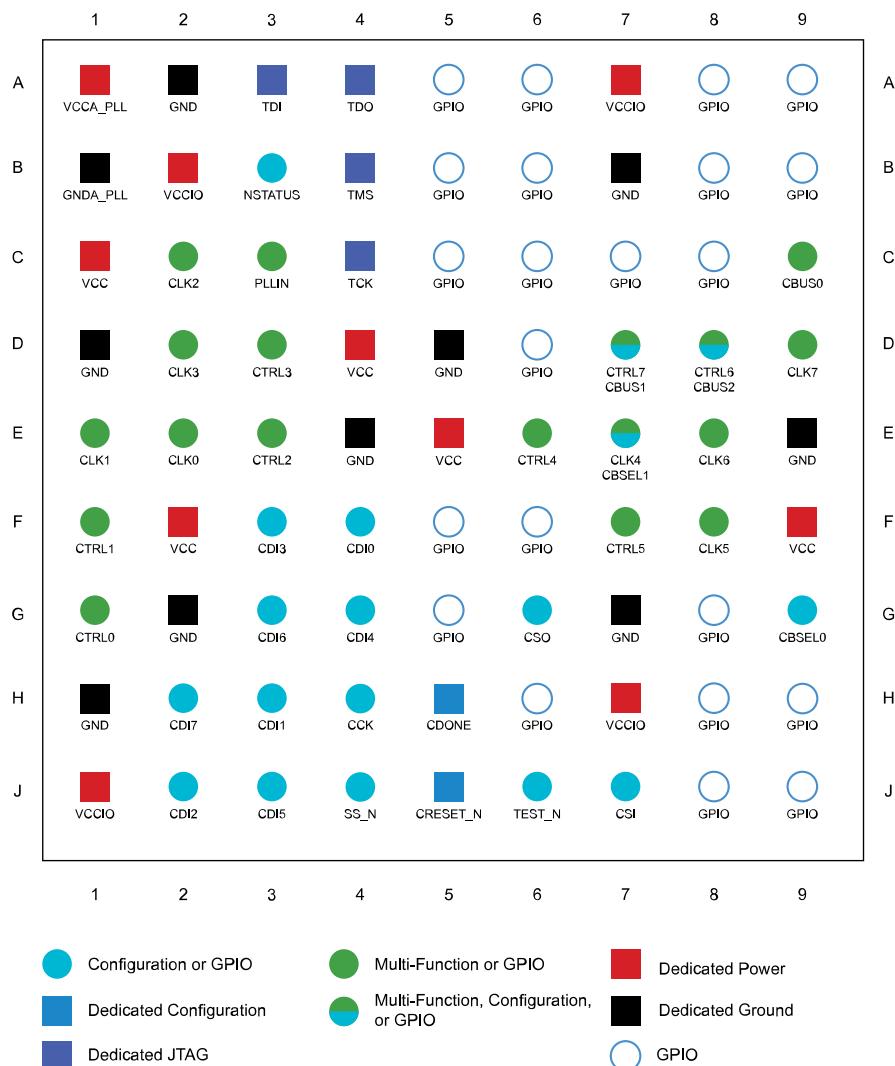


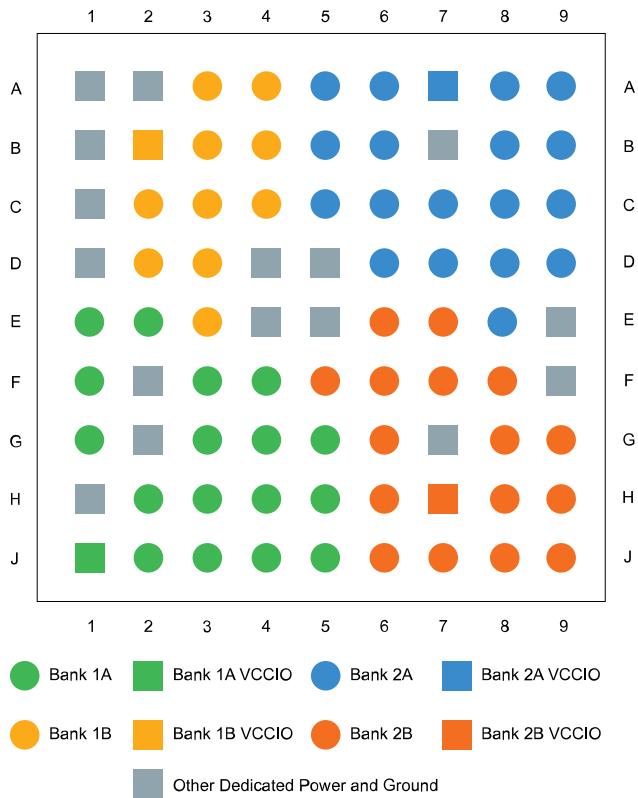
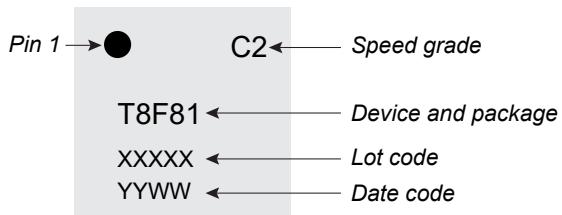
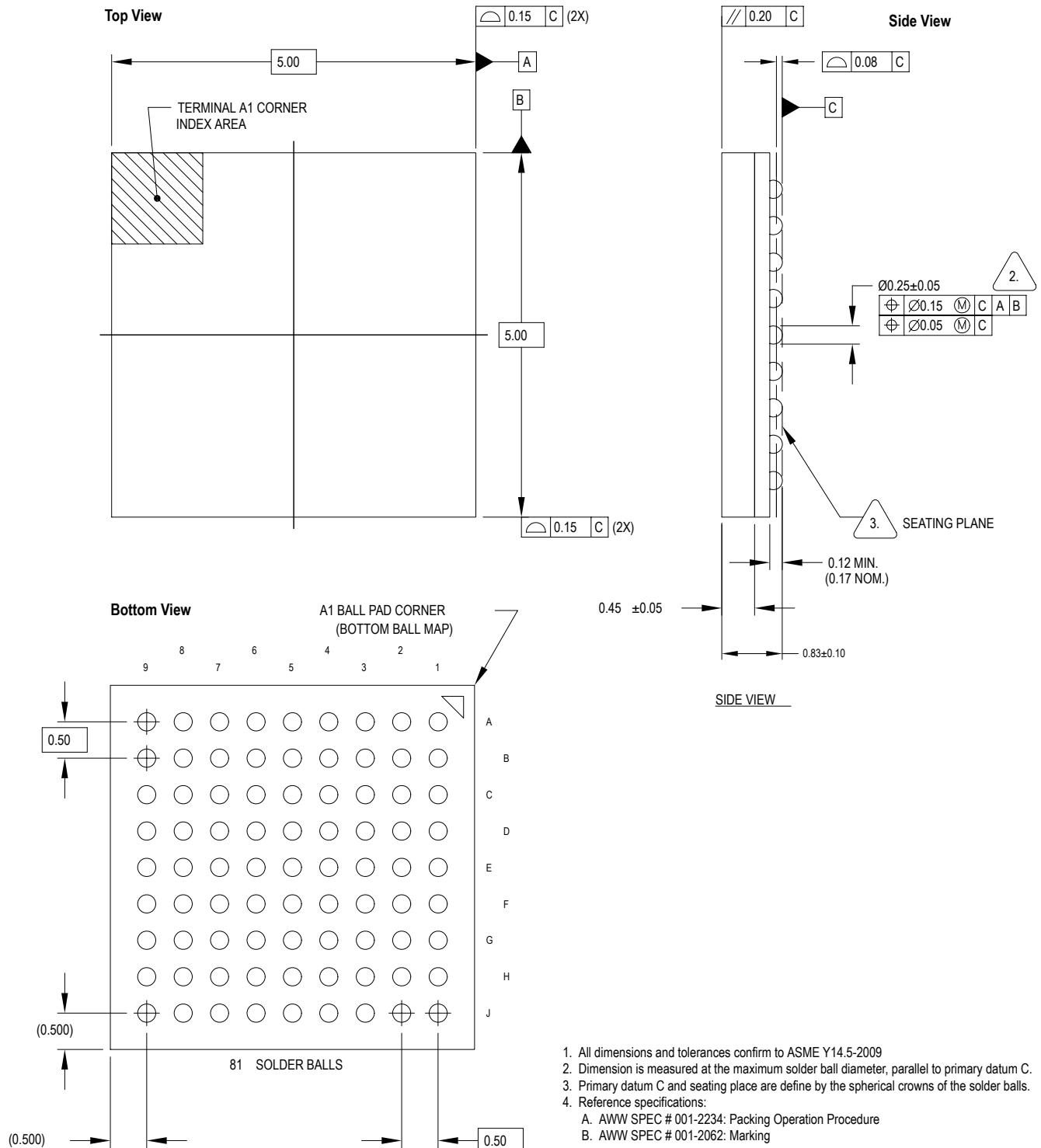
Figure 10: 81-Ball FBGA I/O Bank Diagram**Figure 11: 81-Ball FPGA Package Marking**

Figure 12: 81-Ball FBGA Package Outline



100-Lead LQFP Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package.

Figure 13: 100-Lead LQFP Pinout Diagram

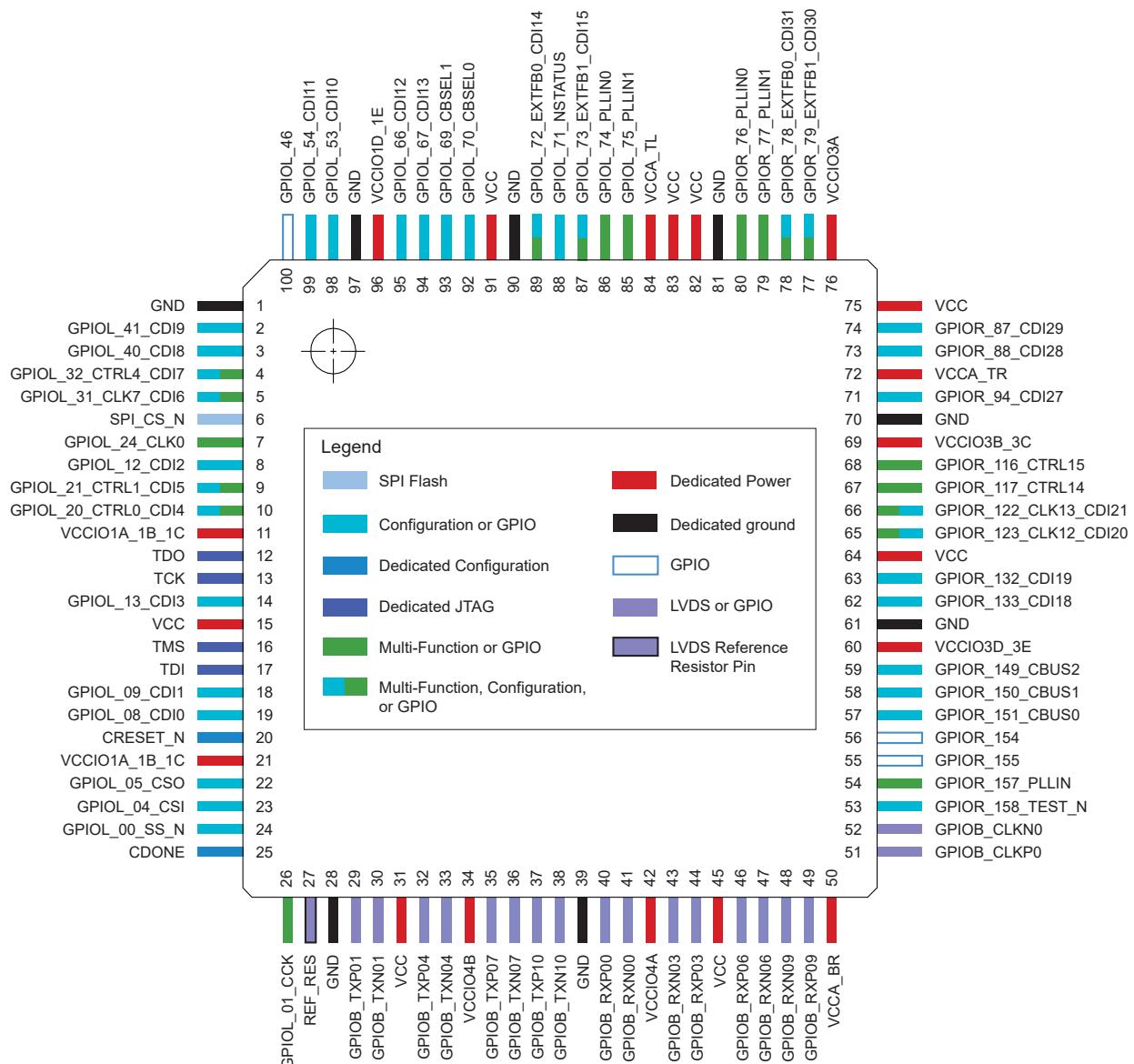


Figure 14: 100-Lead LQFP I/O Bank Diagram

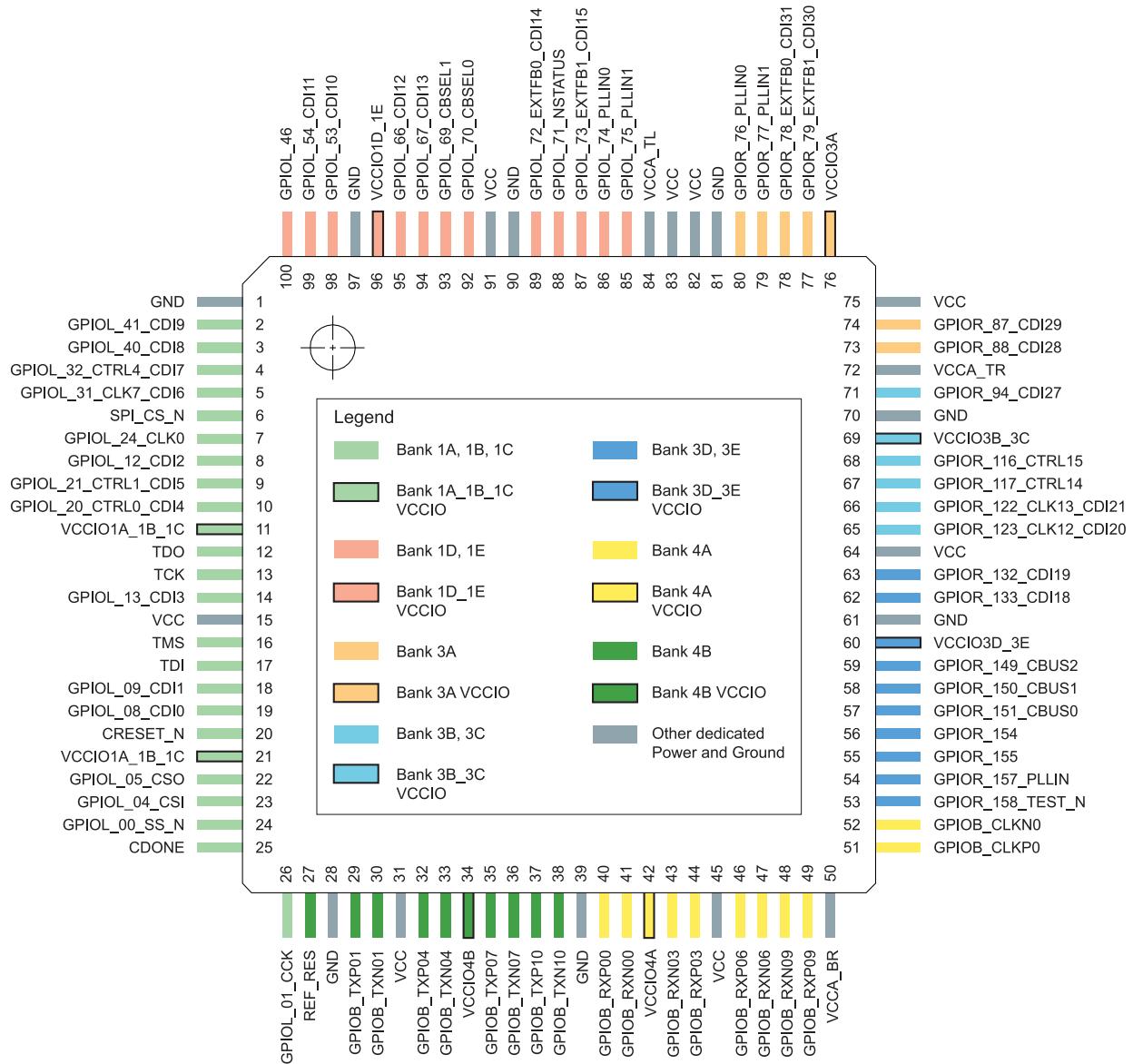
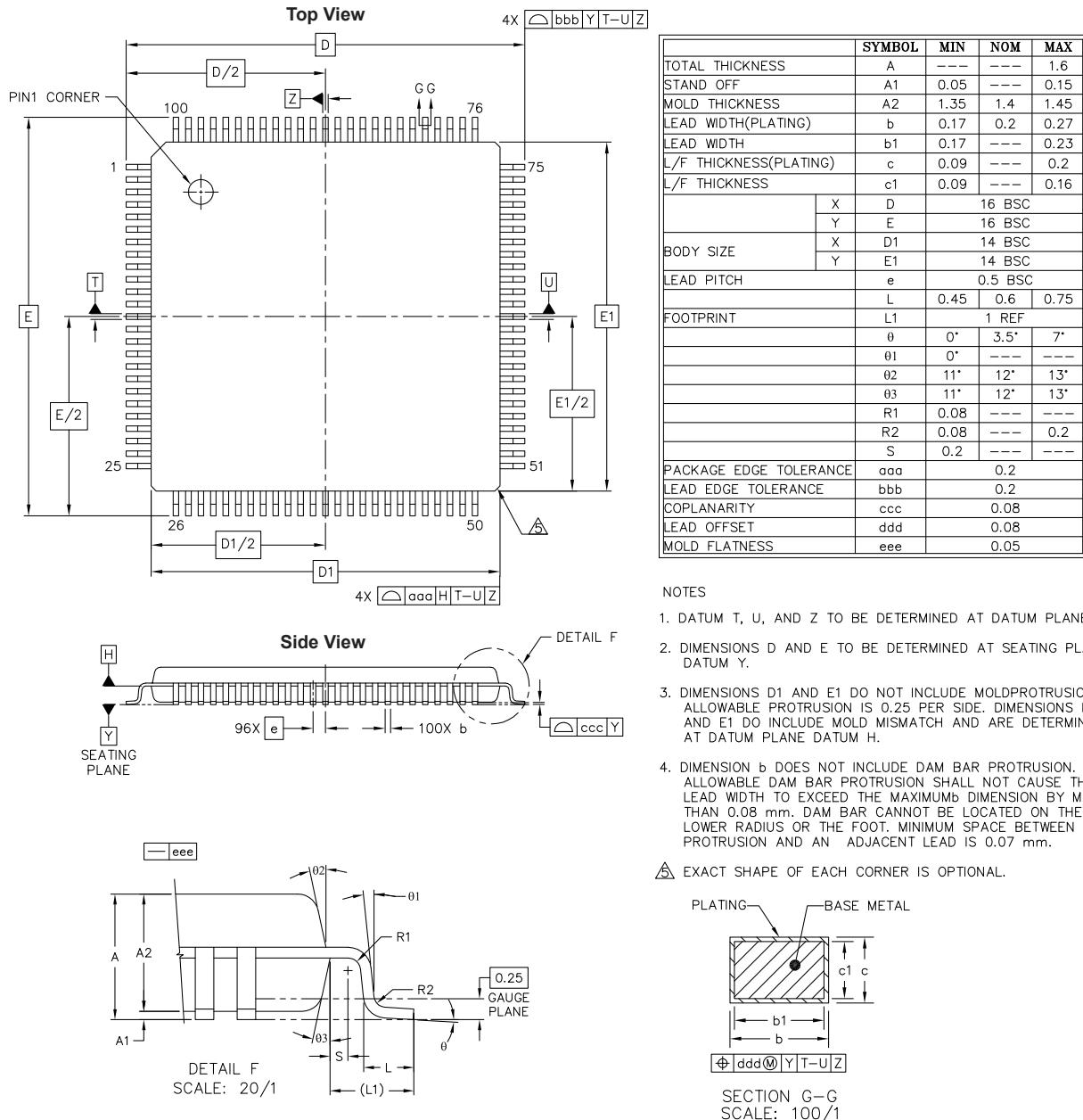


Figure 15: 100-Lead LQFP FPGA Package Marking



Figure 16: 100-Lead LQFP FPGA Package Outline



144-Lead LQFP Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package.

Figure 17: 144-Lead LQFP Pinout Diagram

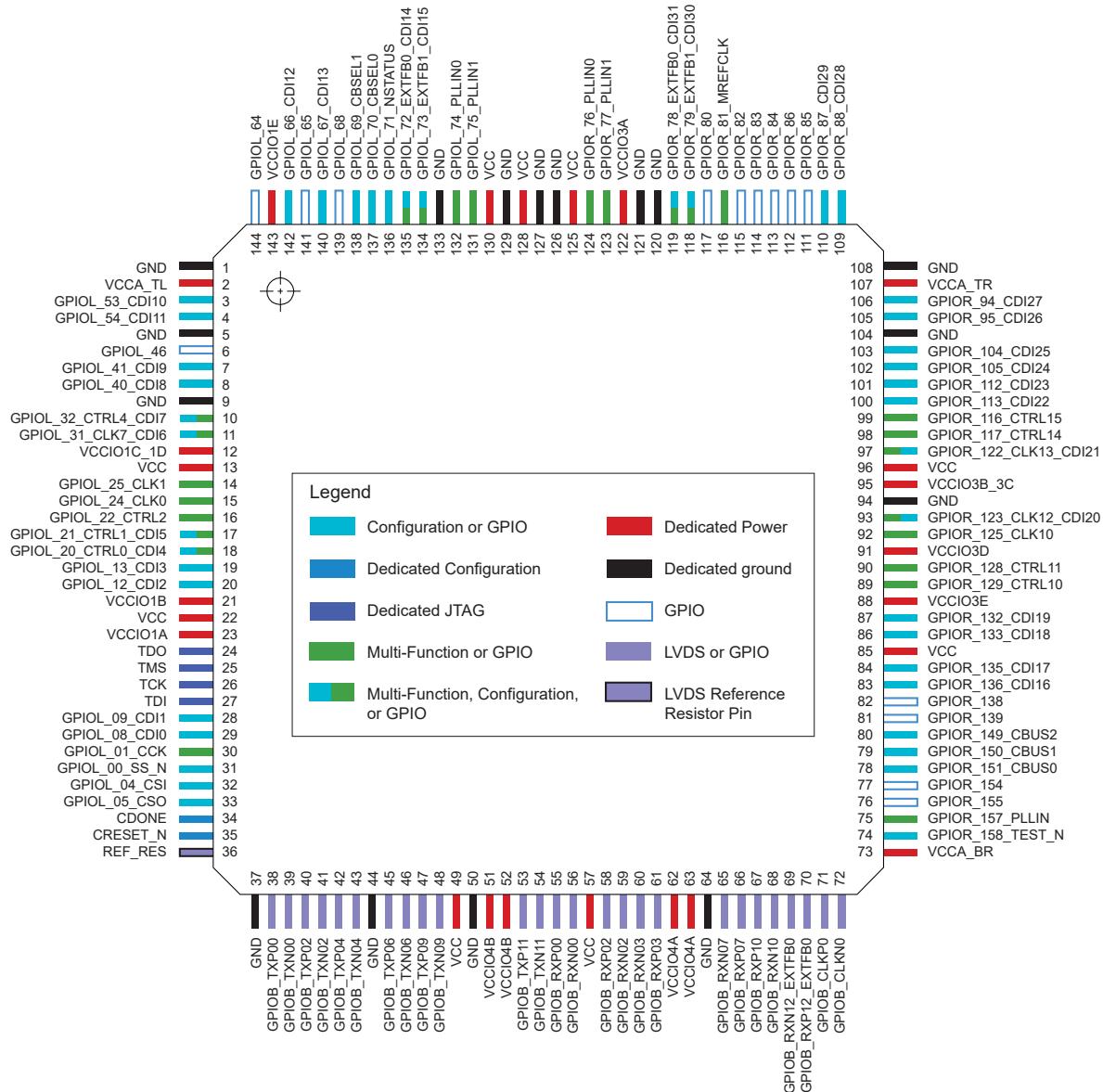


Figure 18: 144-Lead LQFP I/O Bank Diagram

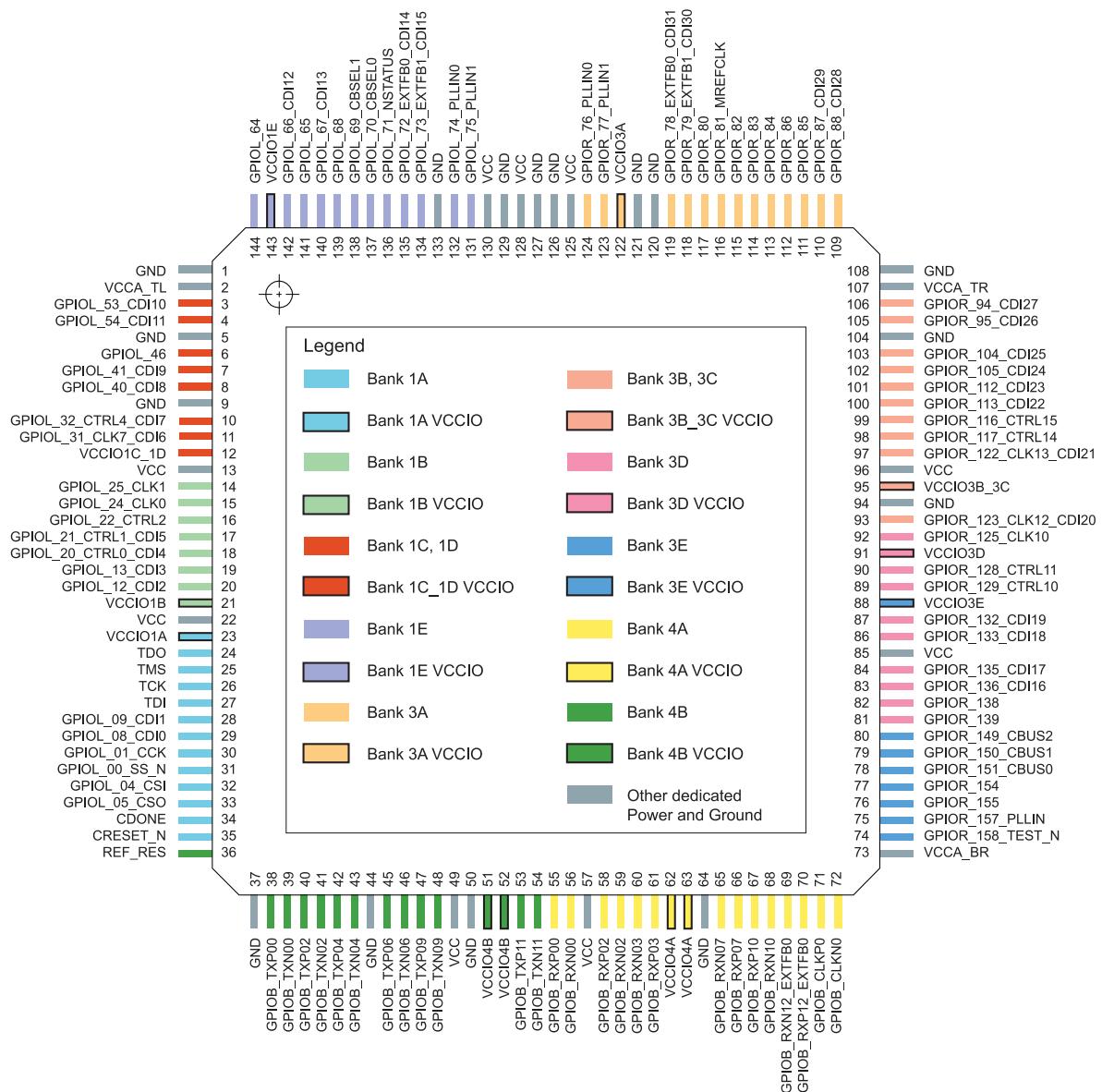
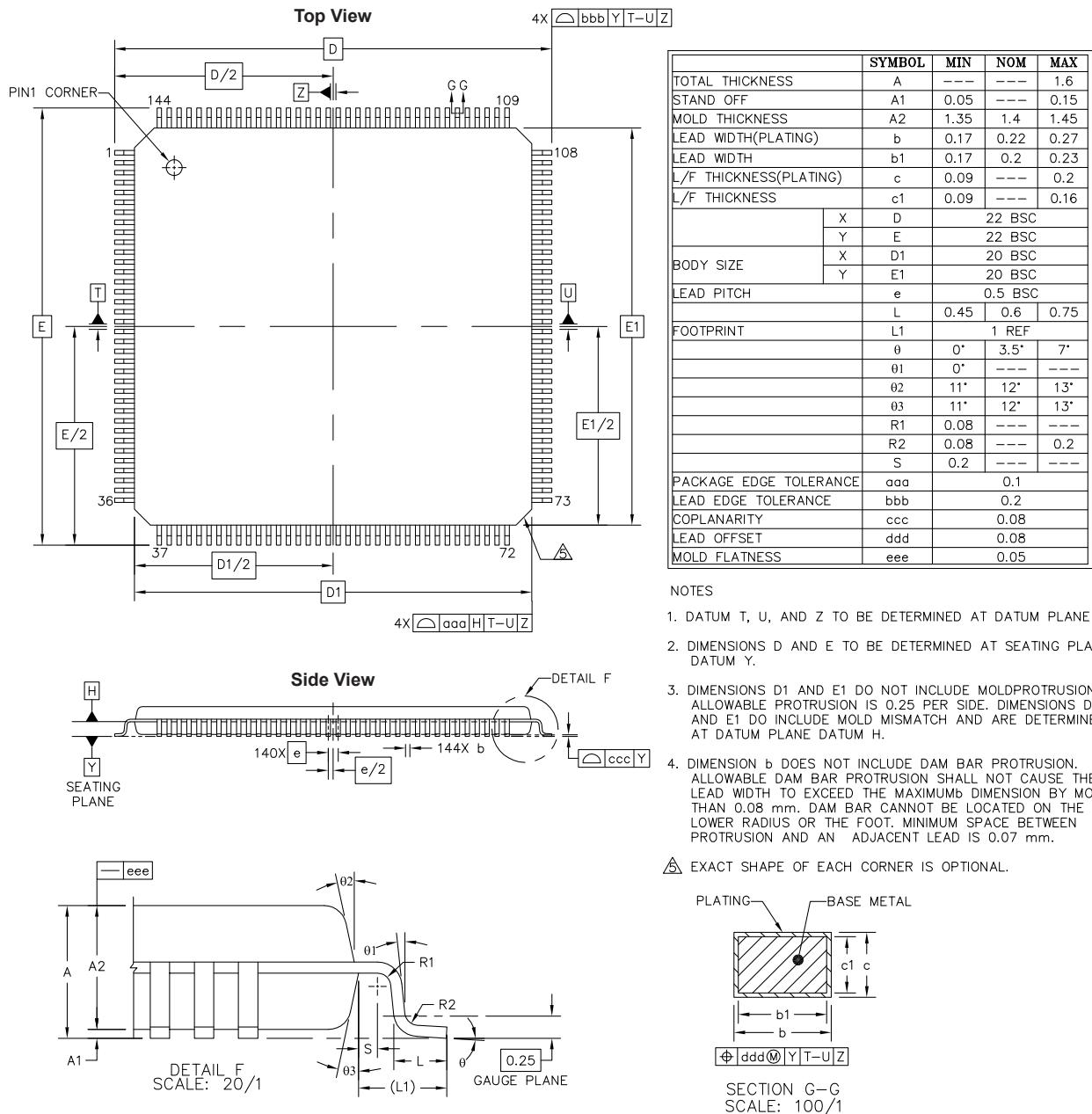


Figure 19: 144-Lead LQFP FPGA Package Marking



Figure 20: 144-Lead LQFP FPGA Package Outline



169-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 21: 169-Ball FBGA Pinout Diagram

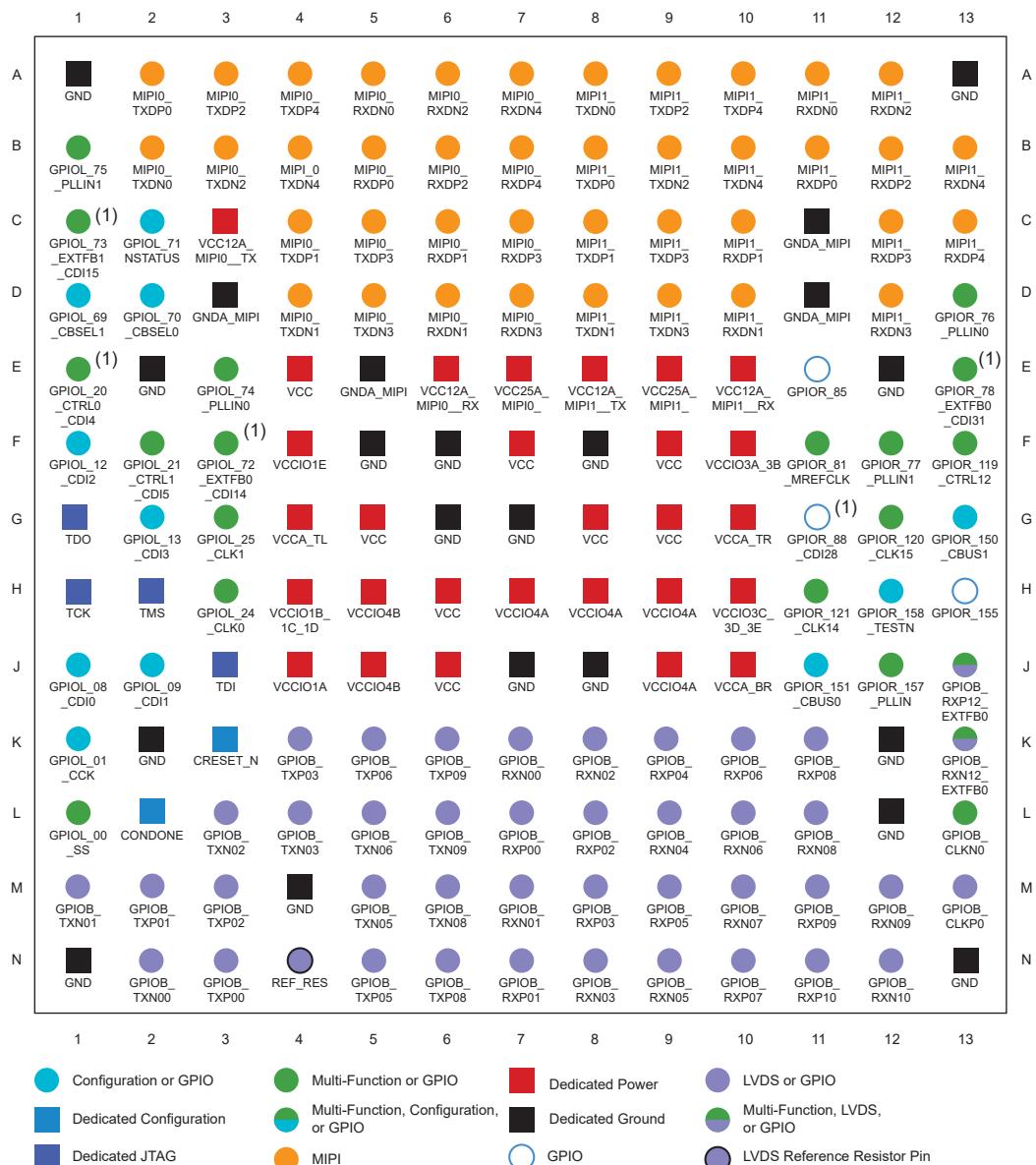


Figure 22: 169-Ball FBGA I/O Bank Diagram

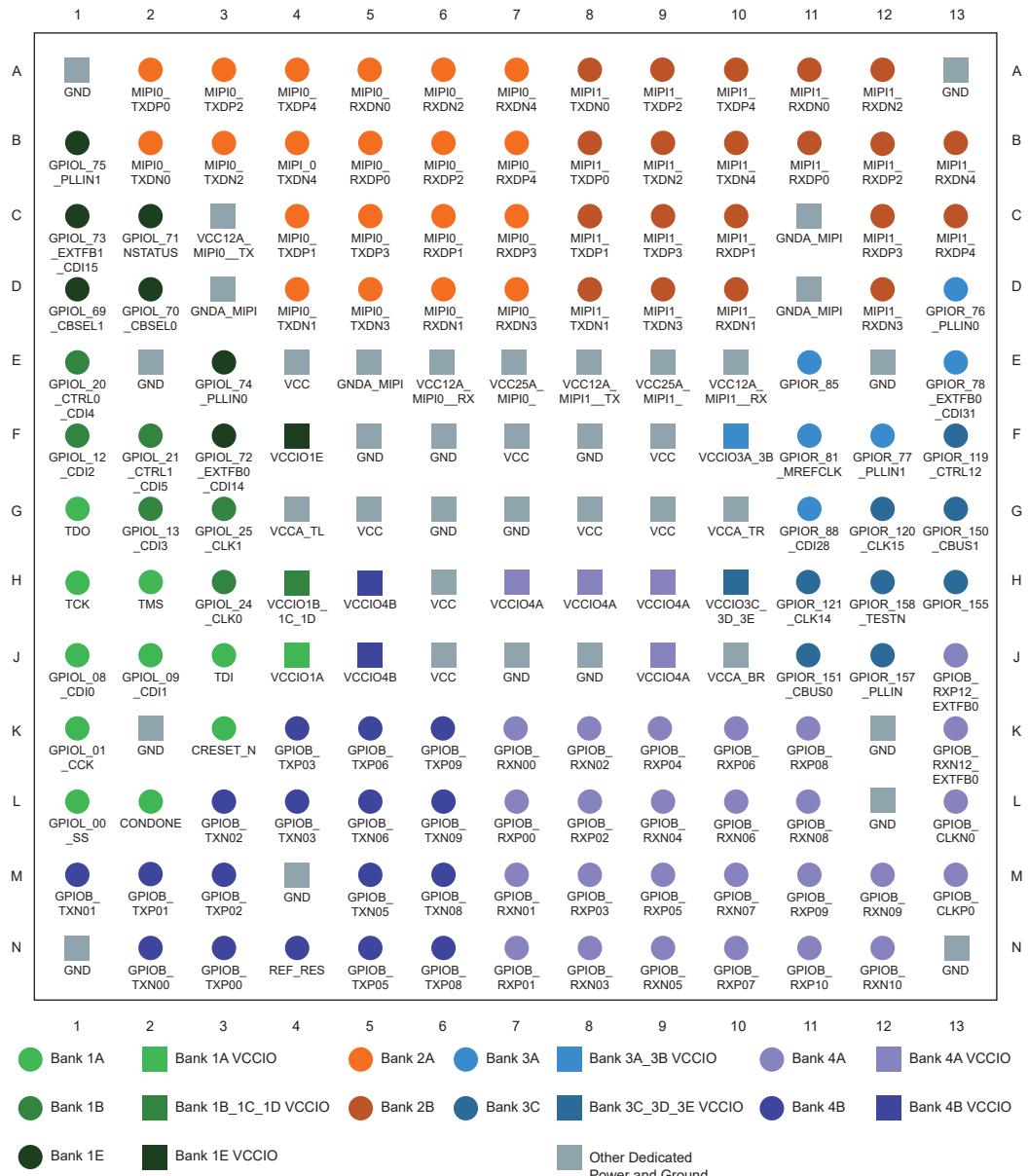


Figure 23: 169-Ball FPGA Package Marking

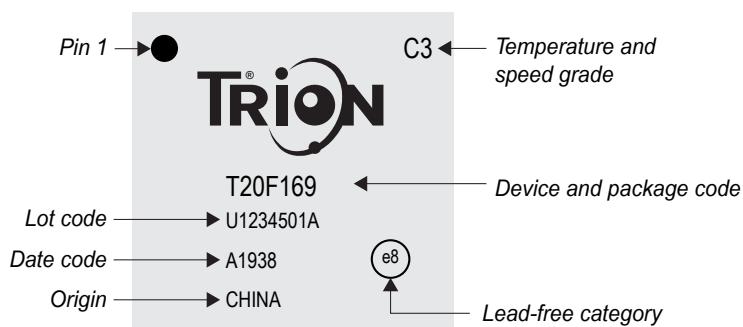
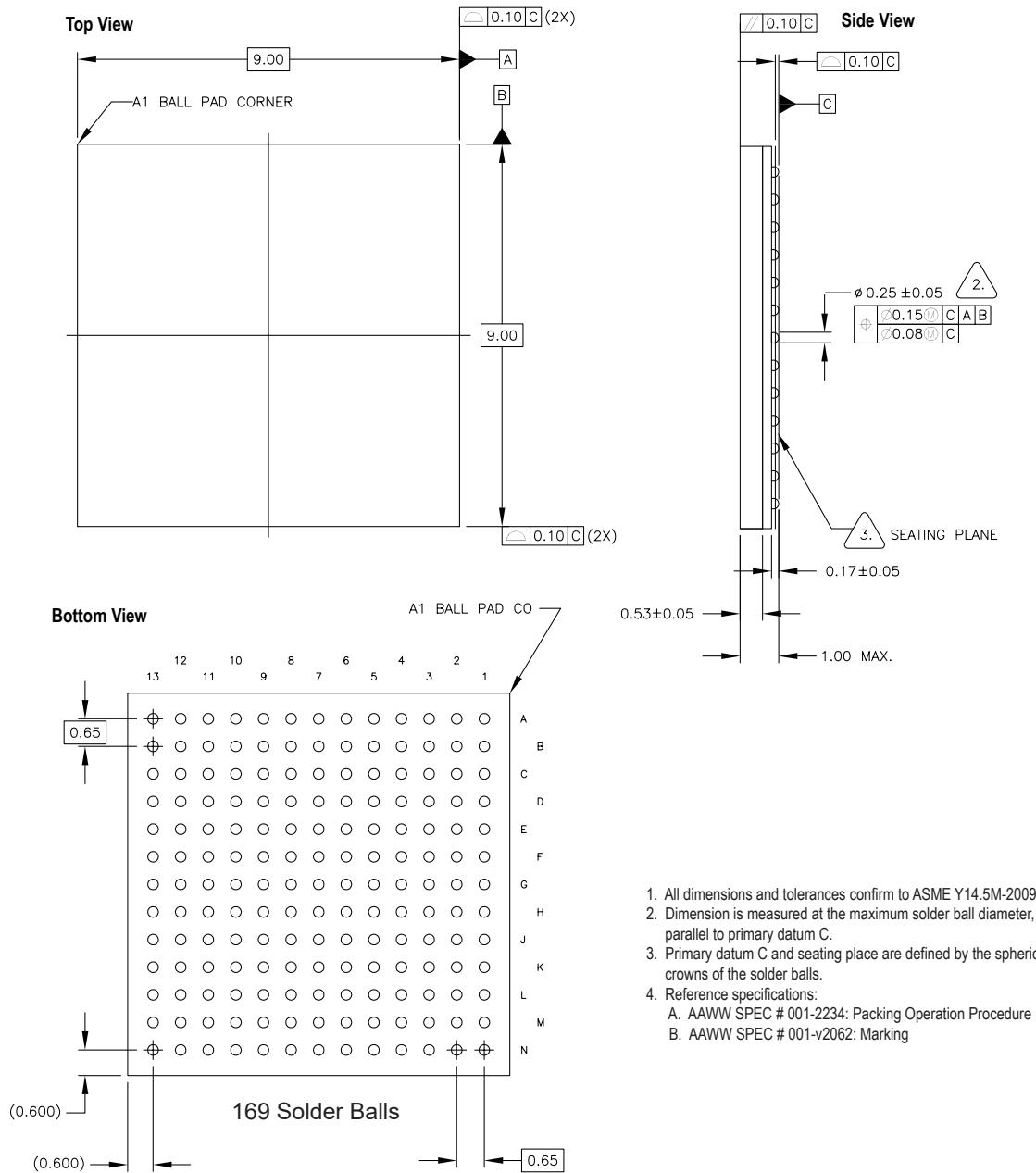


Figure 24: 169-Ball FBGA Package Outline



1. All dimensions and tolerances confirm to ASME Y14.5M-2009
2. Dimension is measured at the maximum solder ball diameter, parallel to primary datum C.
3. Primary datum C and seating place are defined by the spherical crowns of the solder balls.
4. Reference specifications:
 - A. AAWW SPEC # 001-2234: Packing Operation Procedure
 - B. AAWW SPEC # 001-v2062: Marking

256-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 25: 256-Ball FBGA Pinout Diagram

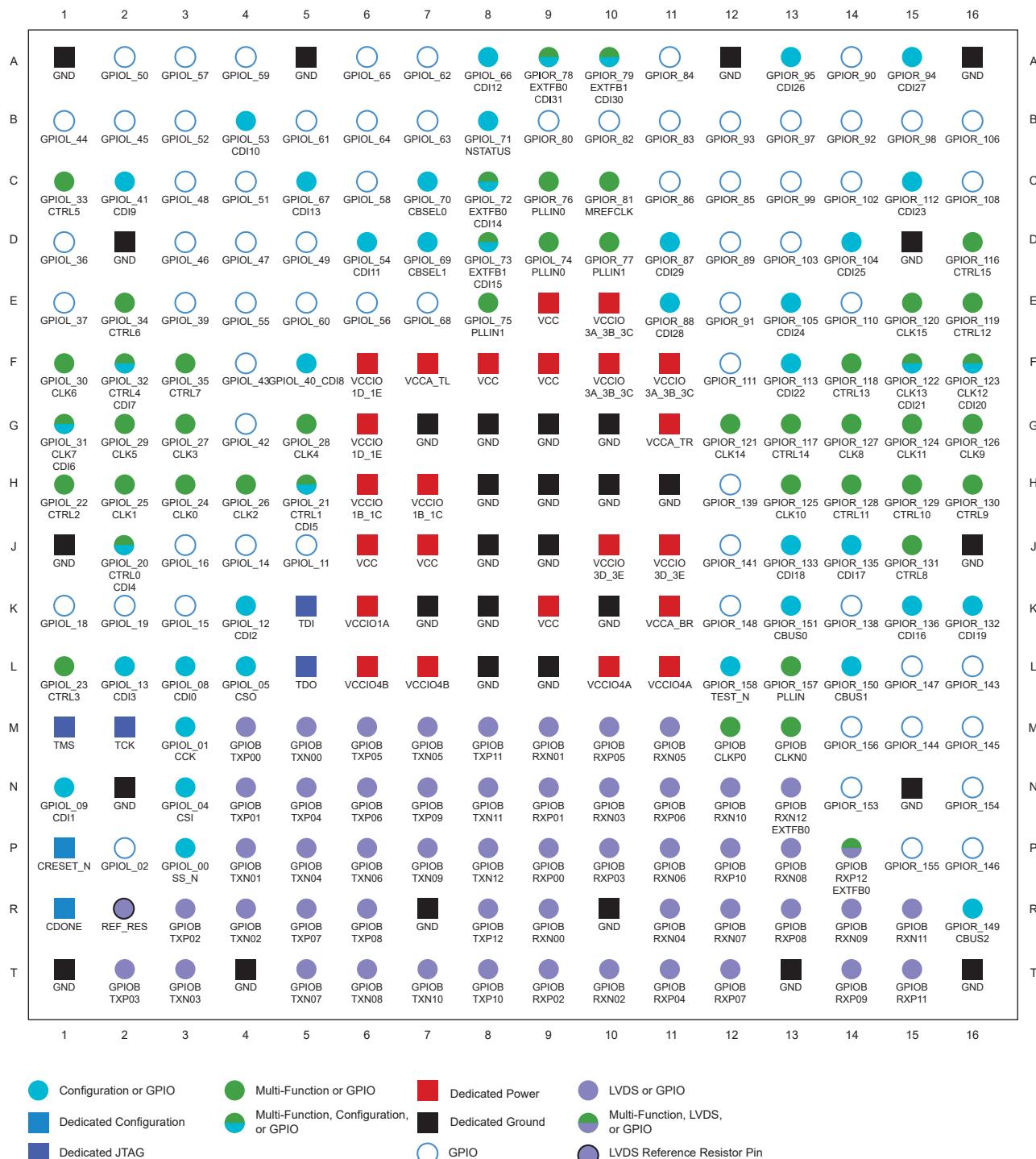


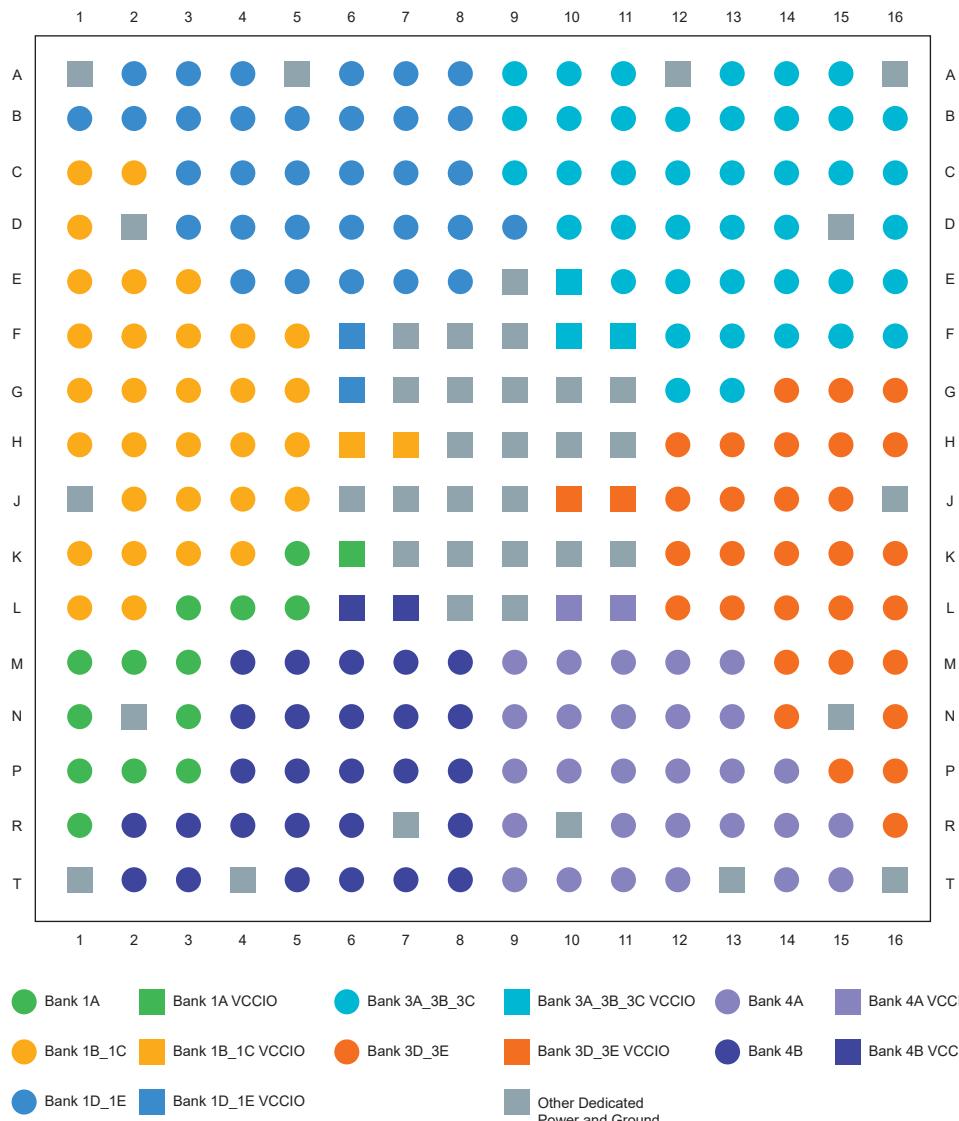
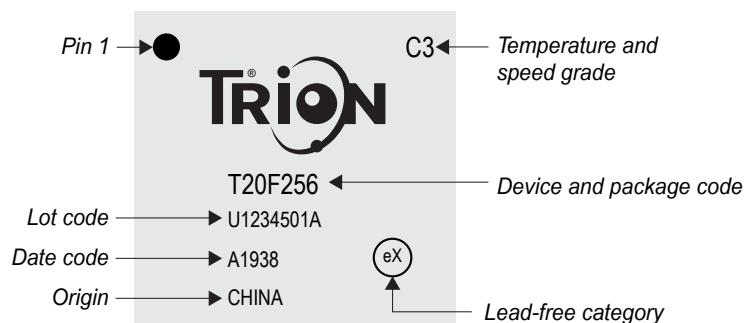
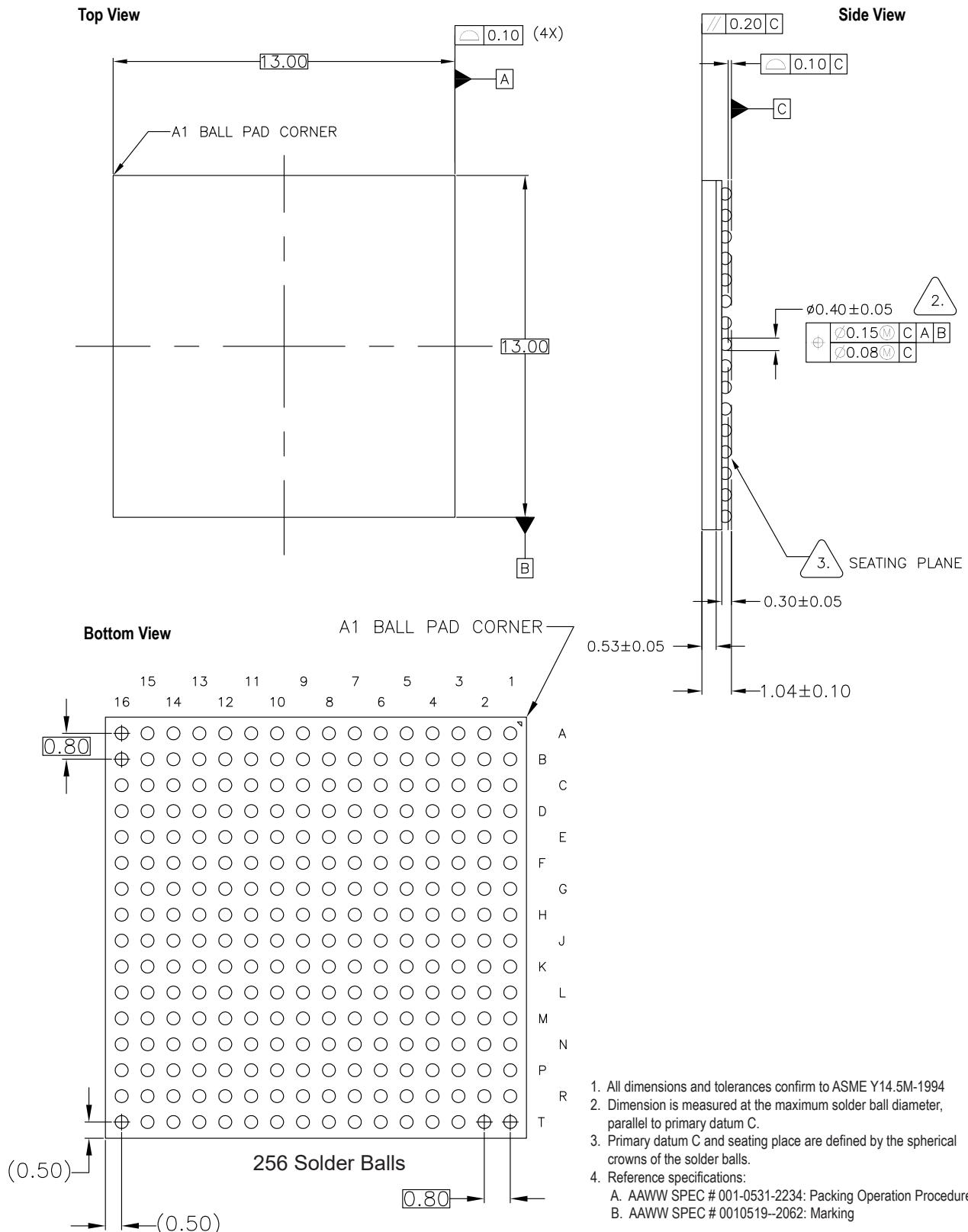
Figure 26: 256-Ball FBGA I/O Bank Diagram**Figure 27: 256-Ball FPGA Package Marking**

Figure 28: 256-Ball FBGA Package Outline



324-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. This is a flip chip package.



Note: Some pin names and I/O banks differ between T20/T35 and T55/T85/T120 FPGAs; however, you can still migrate between FPGAs in this package.

T20 and T35 FPGAs

Pinout and I/O Banks

Figure 29: 324-Ball FBGA Pinout Diagram (T20 and T35)

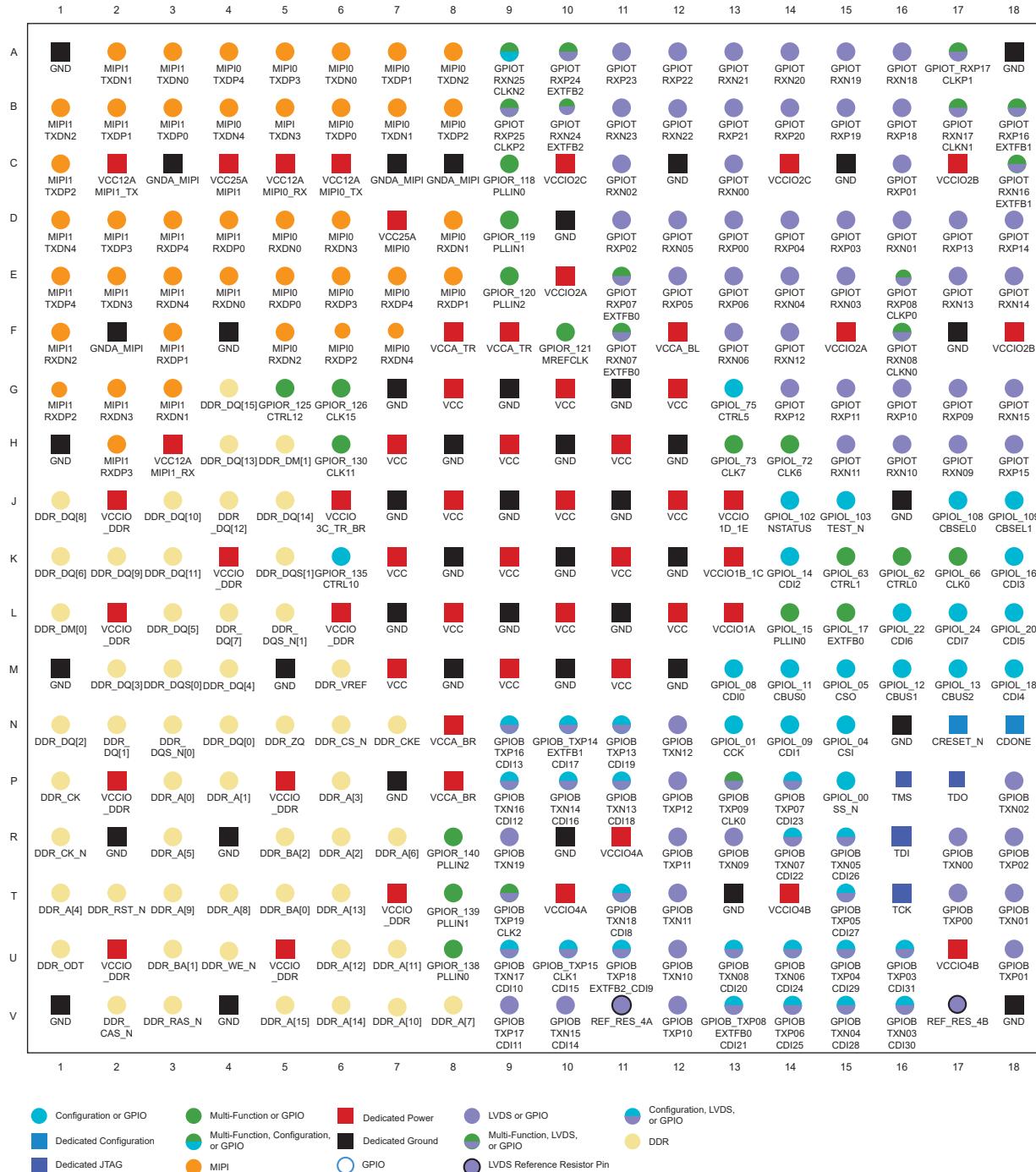
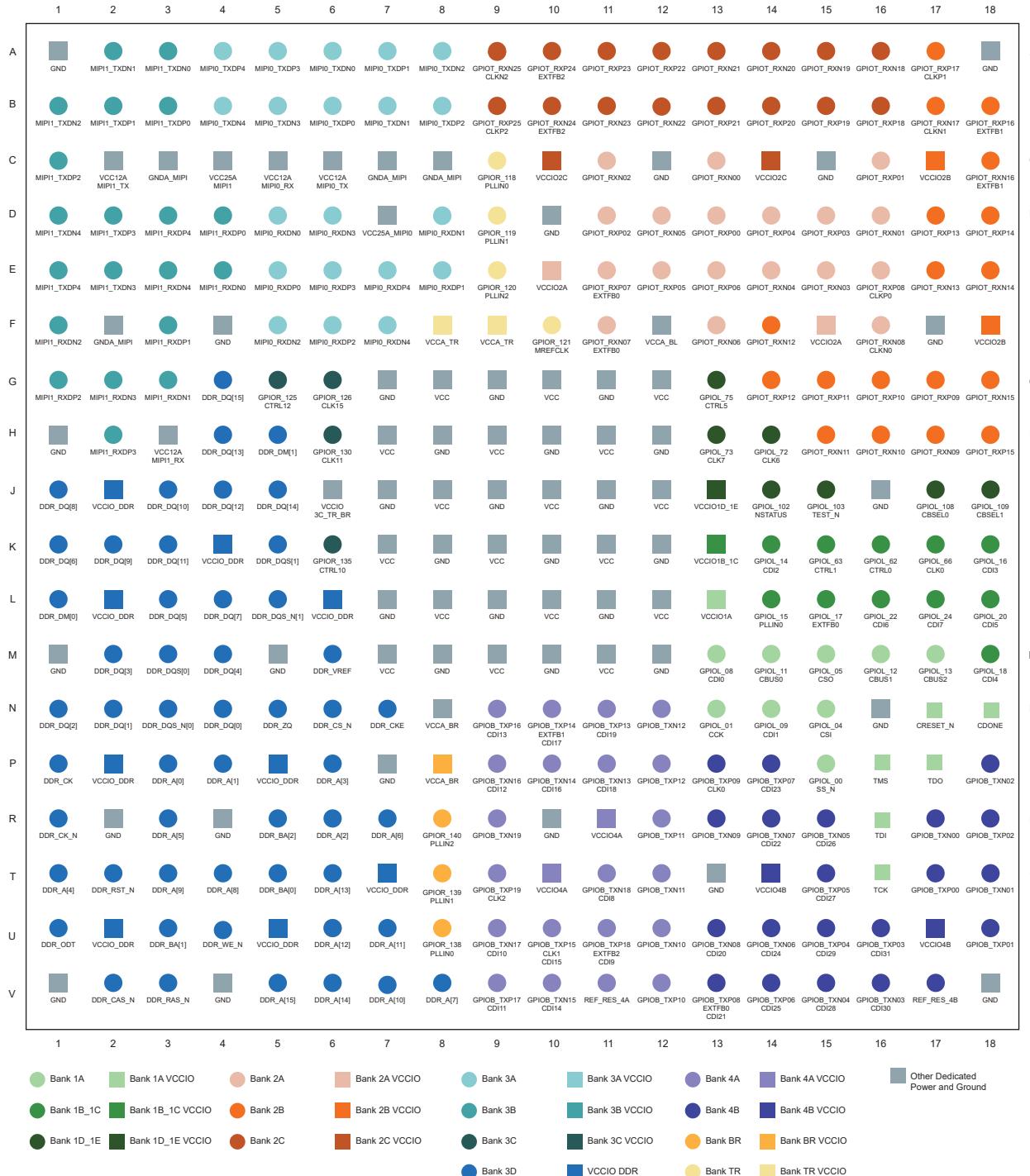


Figure 30: 324-Ball FBGA I/O Bank Diagram (T20 and T35)



Package Outline and Marking

Figure 31: 324-Ball FBGA Package Outline (T20 and T35)

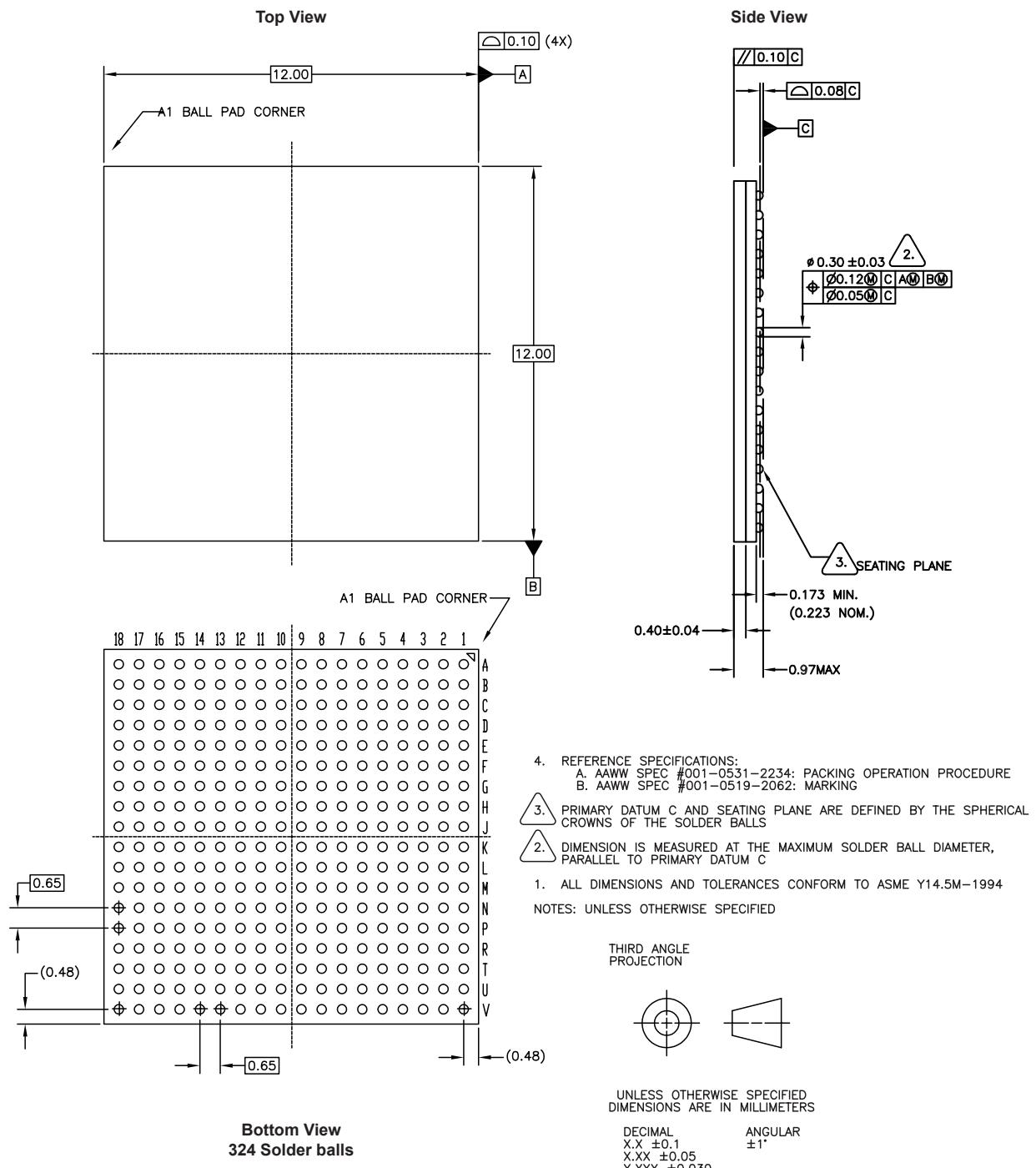
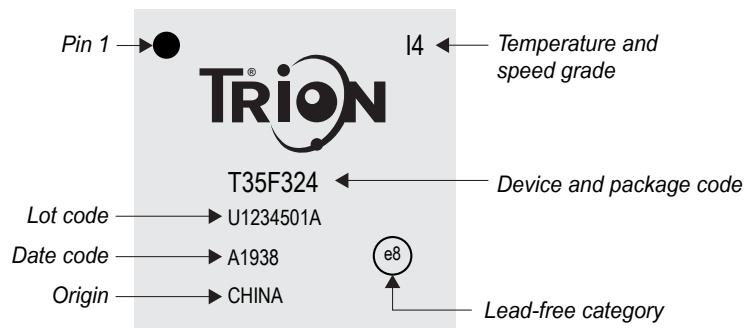


Figure 32: 324-Ball FPGA Package Marking (T20 and T35)



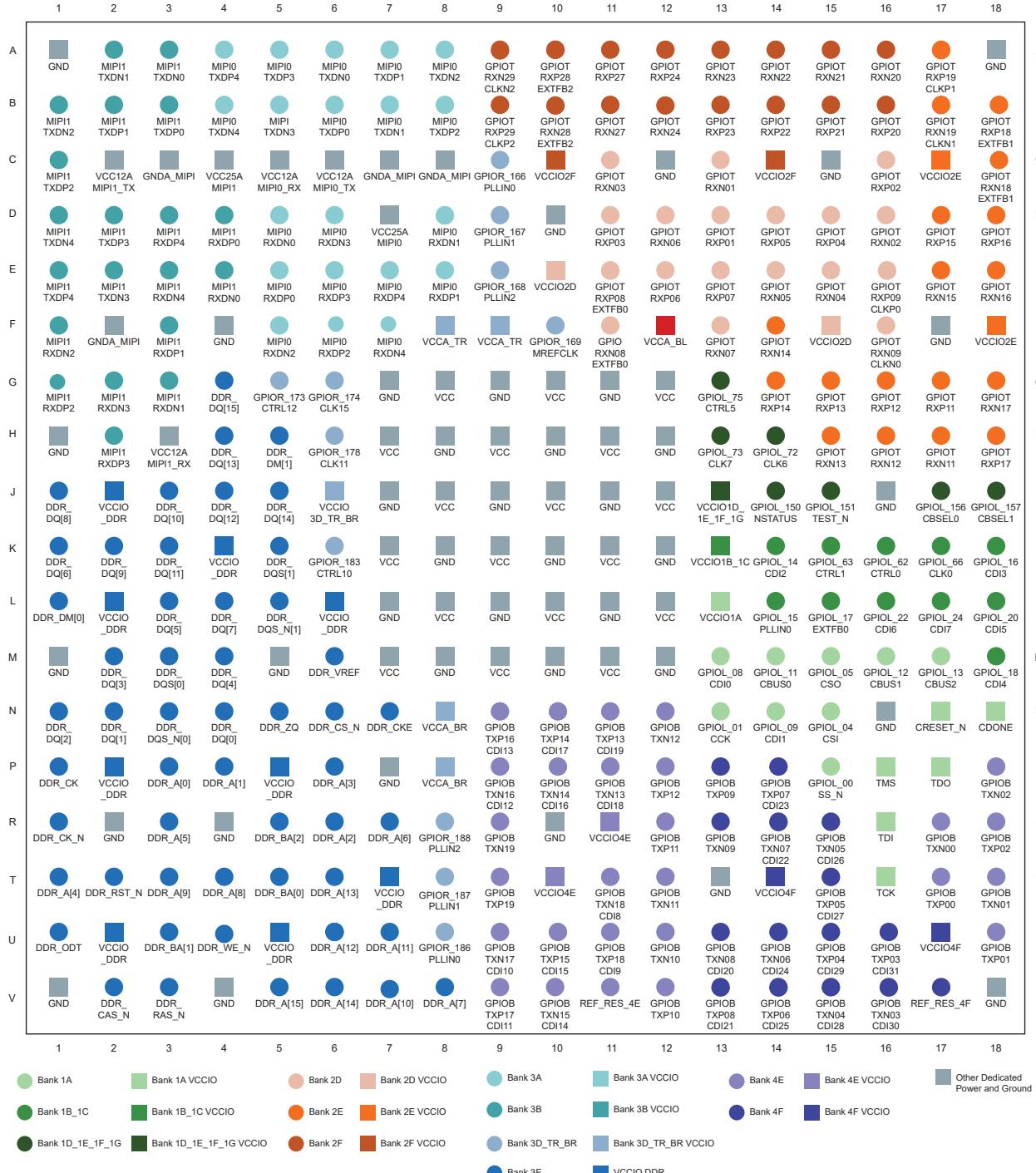
T55, T85, and T120 FPGAs

Pinout and I/O Banks

Figure 33: 324-Ball FBGA Pinout Diagram (T55, T85, and T120)



Figure 34: 324-Ball FBGA I/O Bank Diagram (T55, T85, and T120)



Package Outline and Marking

Figure 35: 324-Ball FBGA Package Outline (T55, T85, and T120)

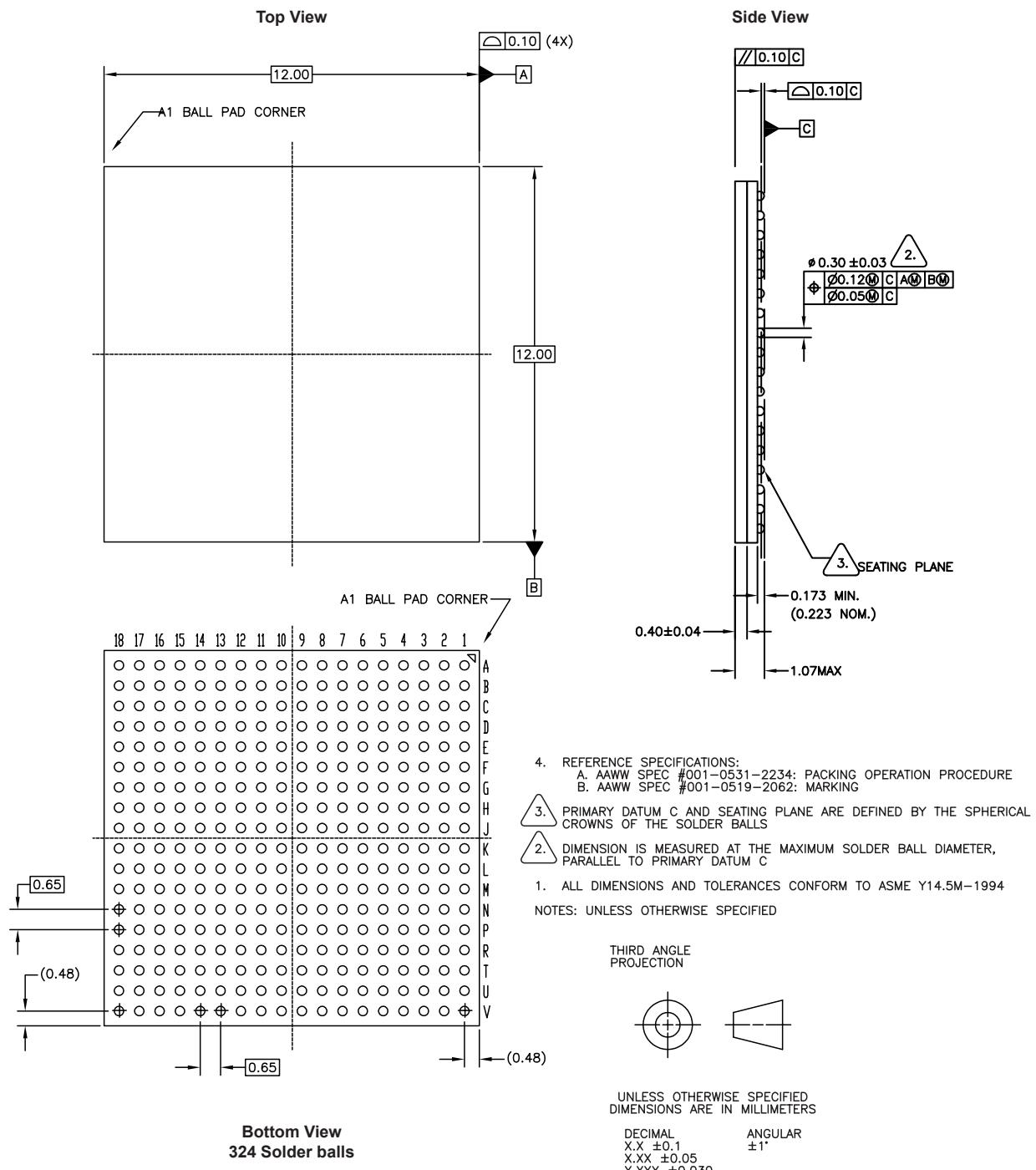
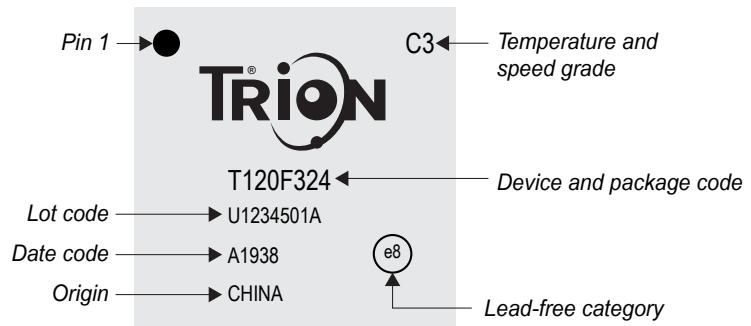


Figure 36: 324-Ball FPGA Package Marking (T55, T85, and T120)



400-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. This is a flip chip package. FPGAs in this package are pin compatible.

Figure 37: 400-Ball FBGA Pinout Diagram



Figure 38: 400-Ball FBGA I/O Bank Diagram

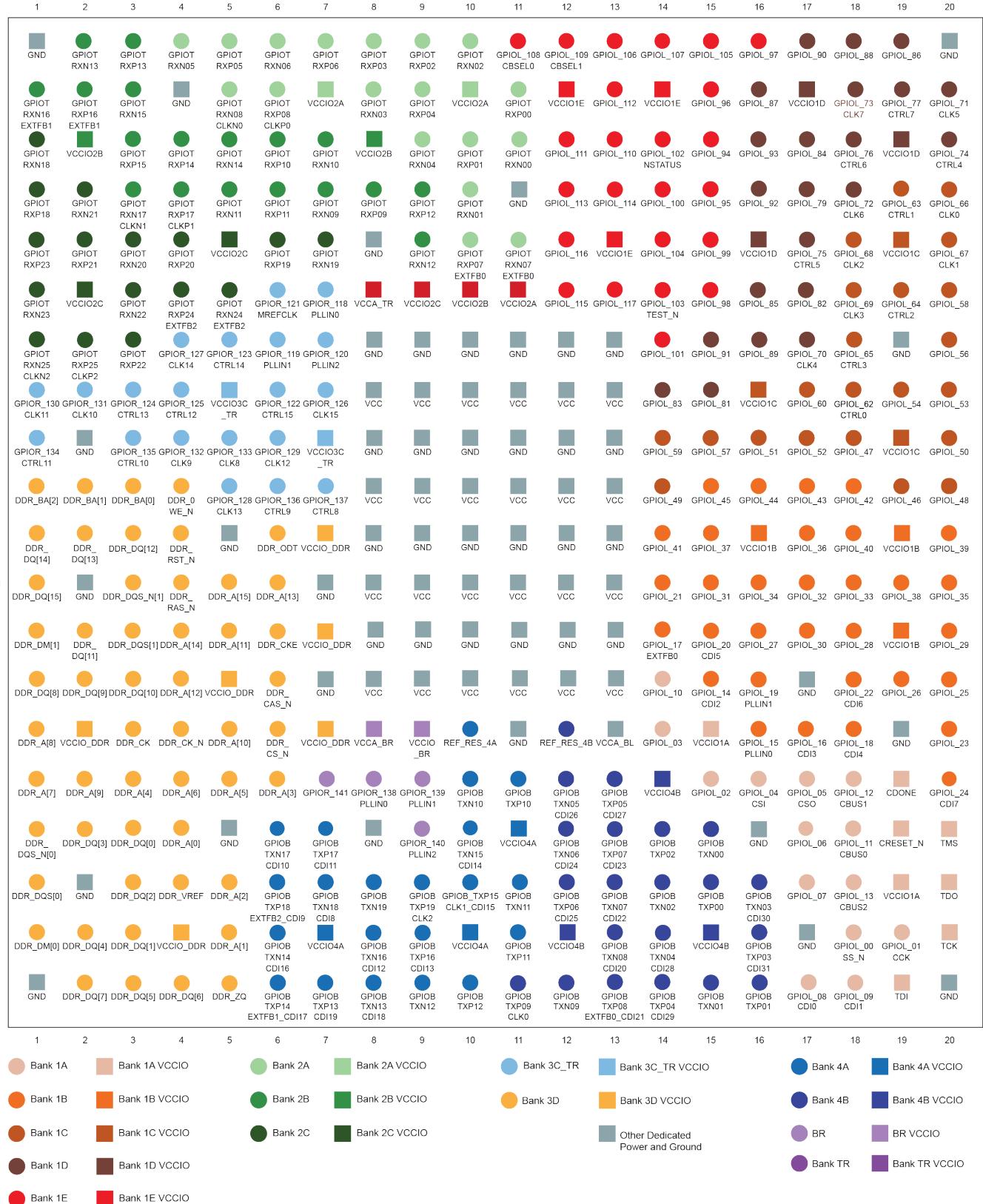


Figure 39: 400-Ball FBGA Package Outline

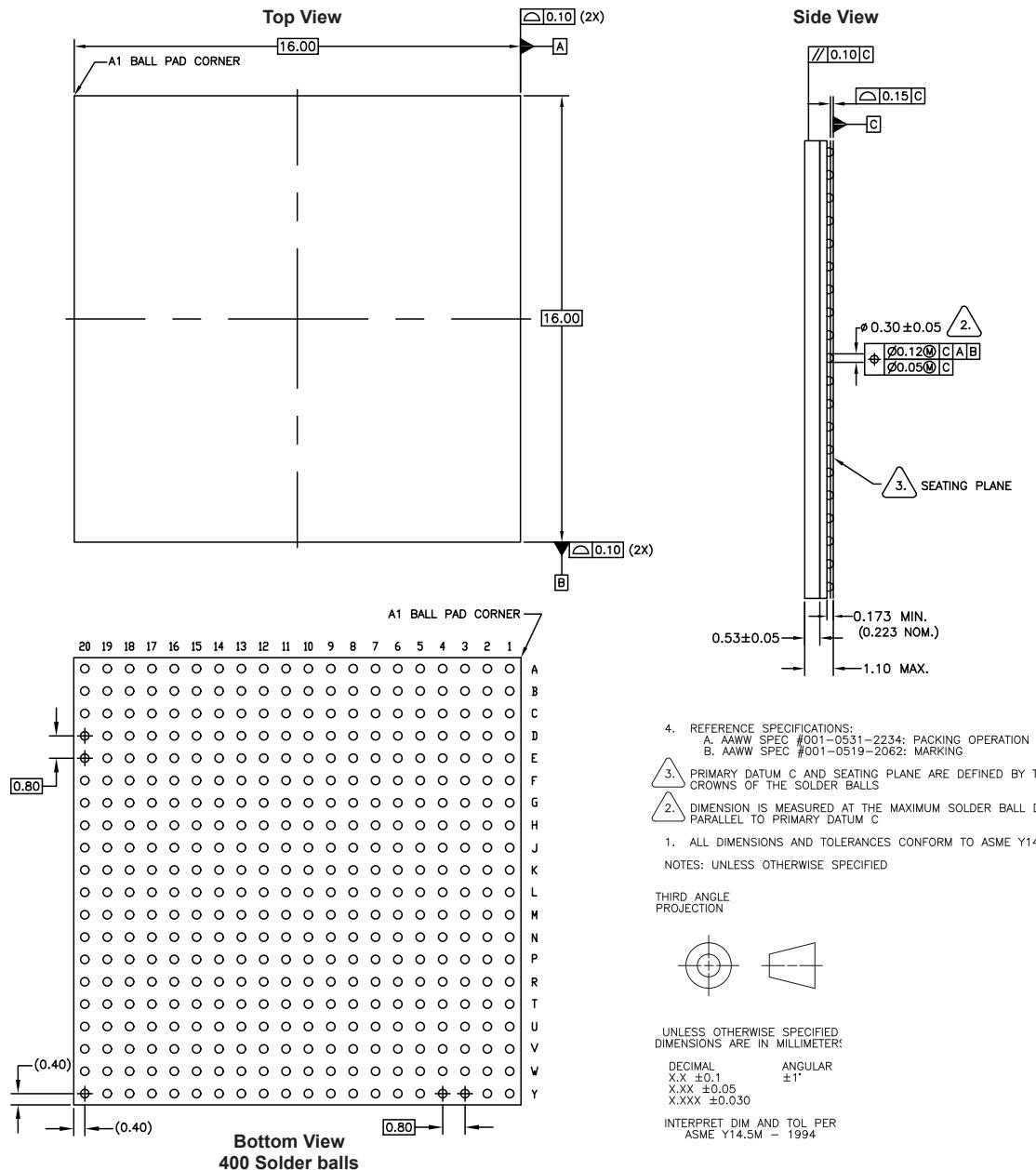
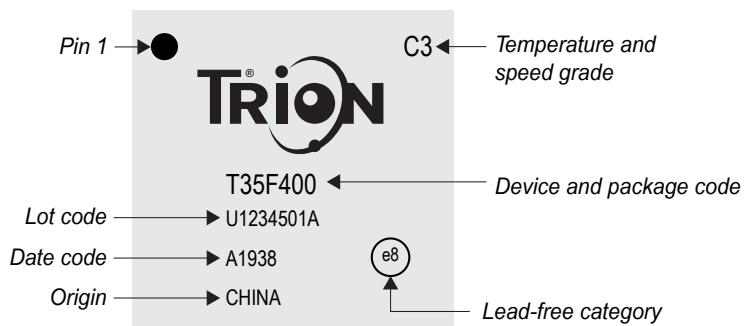


Figure 40: 400-Ball FPGA Package Marking



484-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. FPGAs in this package are pin compatible.

Figure 41: 484-Ball FBGA Pinout Diagram



- This legend identifies various pin types and power distribution elements:

 - Configuration or GPIO
 - Multi-Function or GPIO
 - Dedicated Power
 - LVDS or GPIO
 - Configuration, LVDS or GPIO
 - Multi-Function, Configuration, or GPIO
 - Dedicated Ground
 - Multi-Function, LVDS, or GPIO
 - Dedicated JTAG
 - GPIO
 - LVDS Reference Resistor Pin
 - DDR

Figure 42: 484-Ball FBGA I/O Bank Diagram

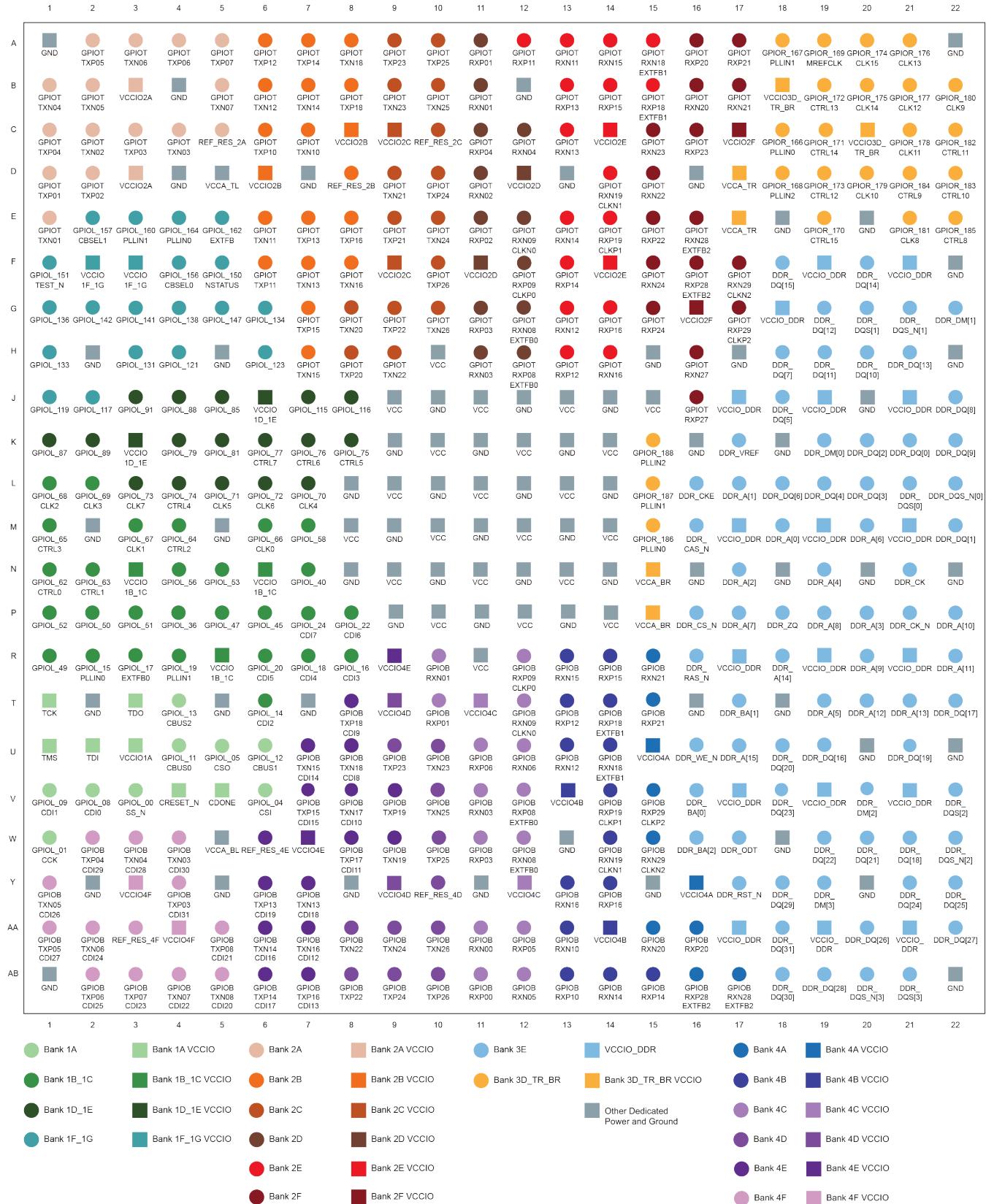


Figure 43: 484-Ball FBGA Package Outline

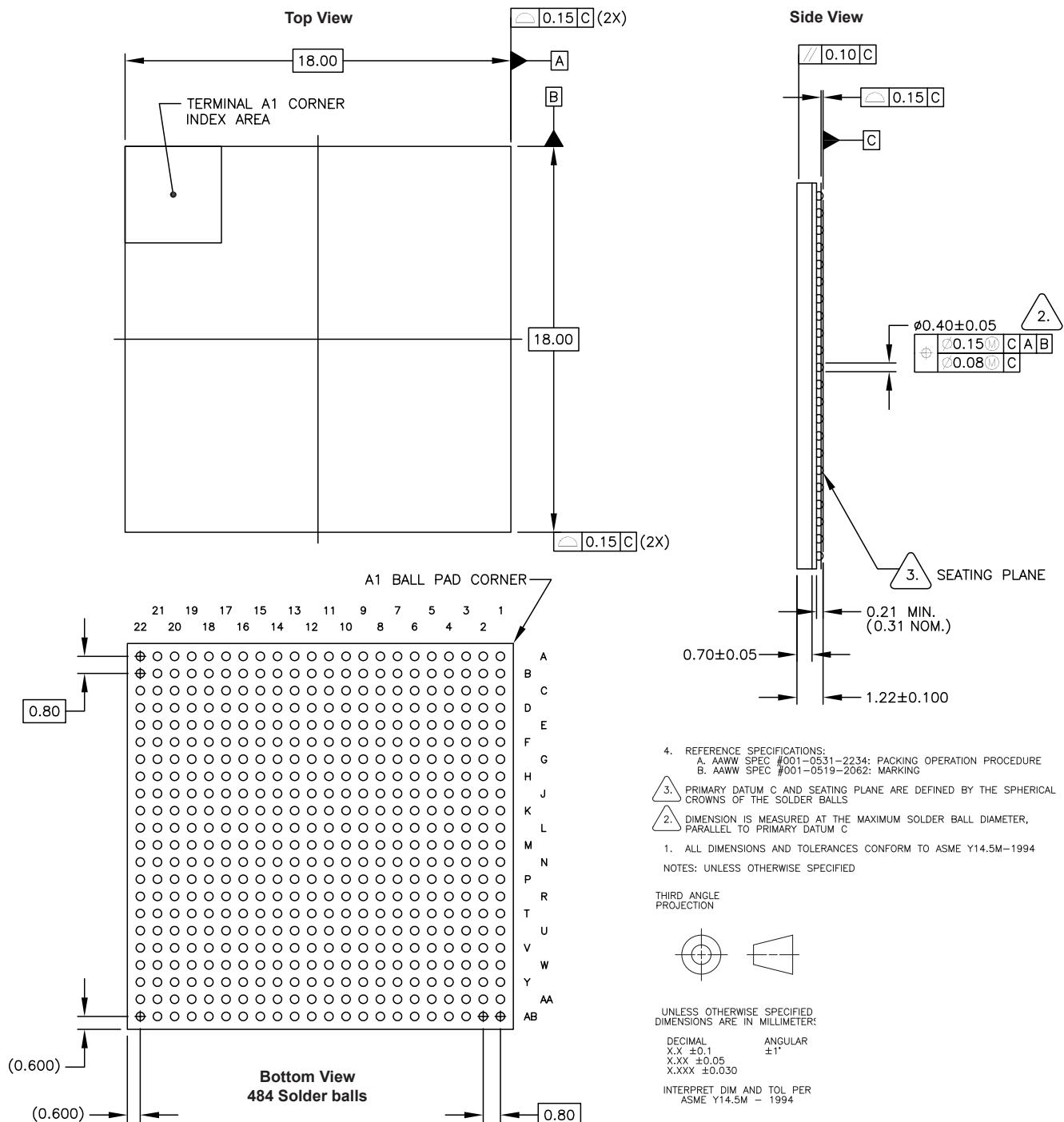
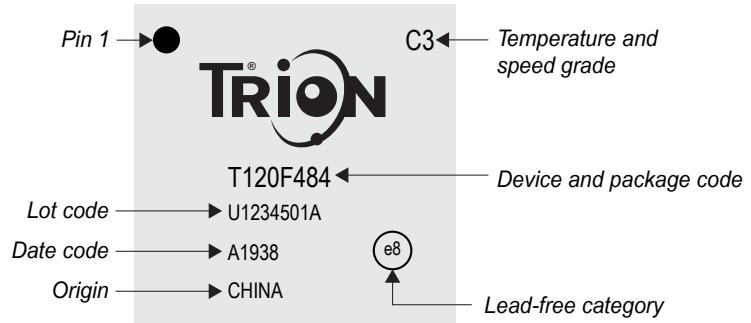


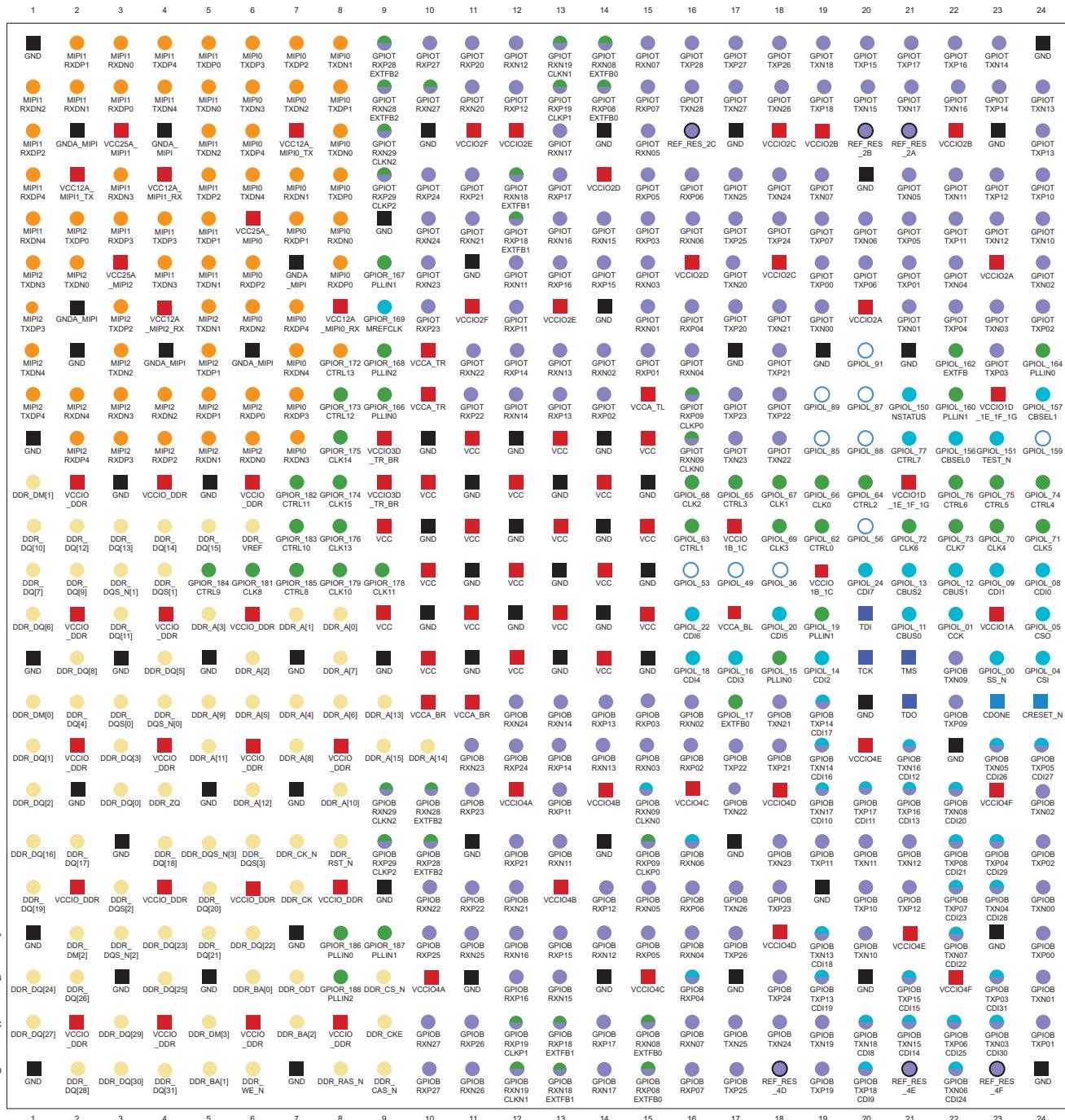
Figure 44: 484-Ball FPGA Package Marking



576-Ball FBGA Package Specifications

The following figures show the pin, I/O bank locations, package top-side marking, and outlines for this package. This is a flip chip package. FPGAs in this package are pin compatible.

Figure 45: 576-Ball FBGA Pinout Diagram



● Configuration or GPIO
■ Dedicated Configuration
■ Dedicated JTAG

● Multi-Function or GPIO
● Multi-Function, Configuration, or GPIO
● MIPI
■ Dedicated Power
■ Dedicated Ground

● LVDS or GPIO
● Multi-Function, LVDS, or GPIO
● LVDS Reference Resistor Pin
○ GPIO

Figure 46: 576-Ball FBGA I/O Bank Diagram

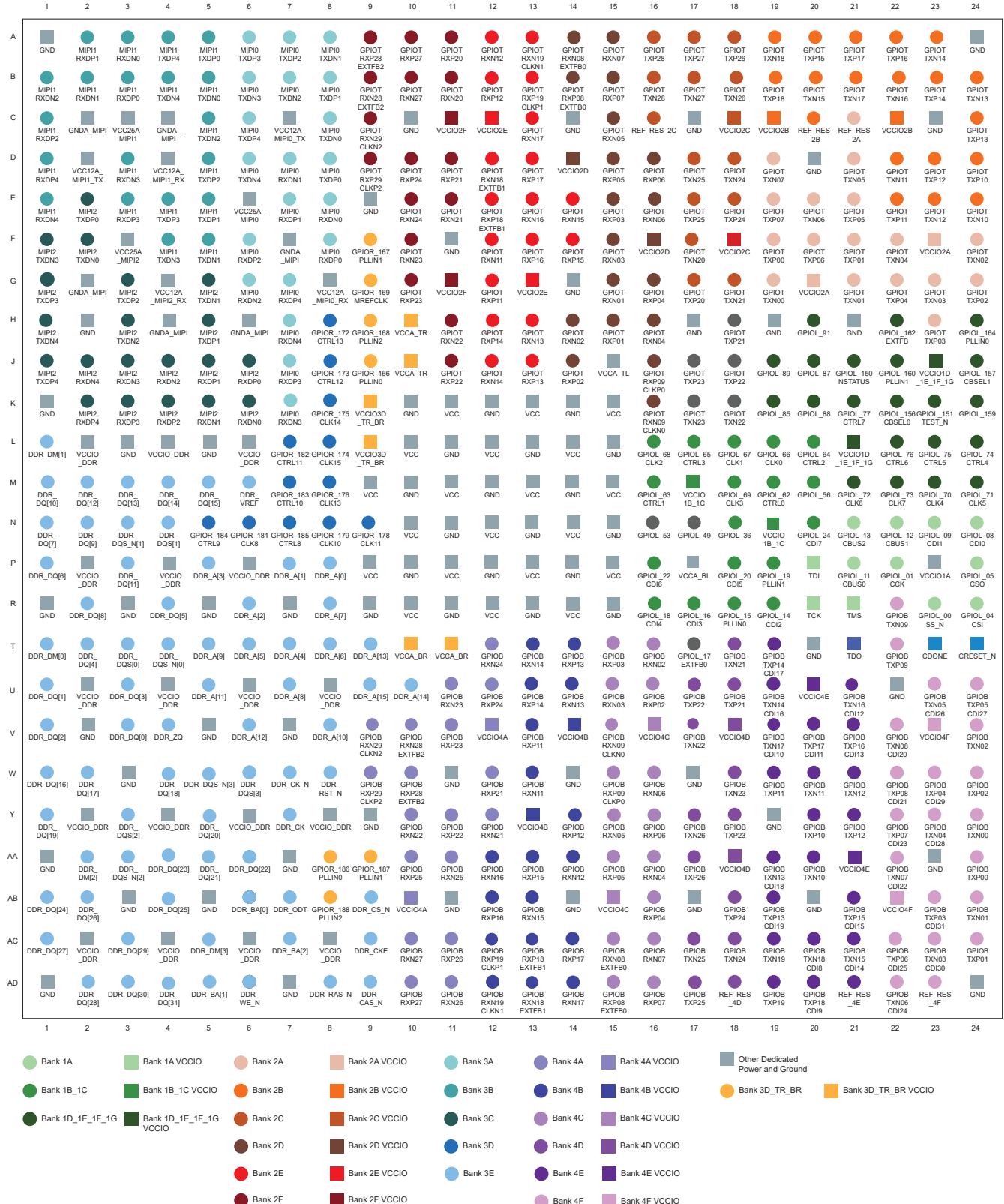


Figure 47: 576-Ball FBGA Package Outline

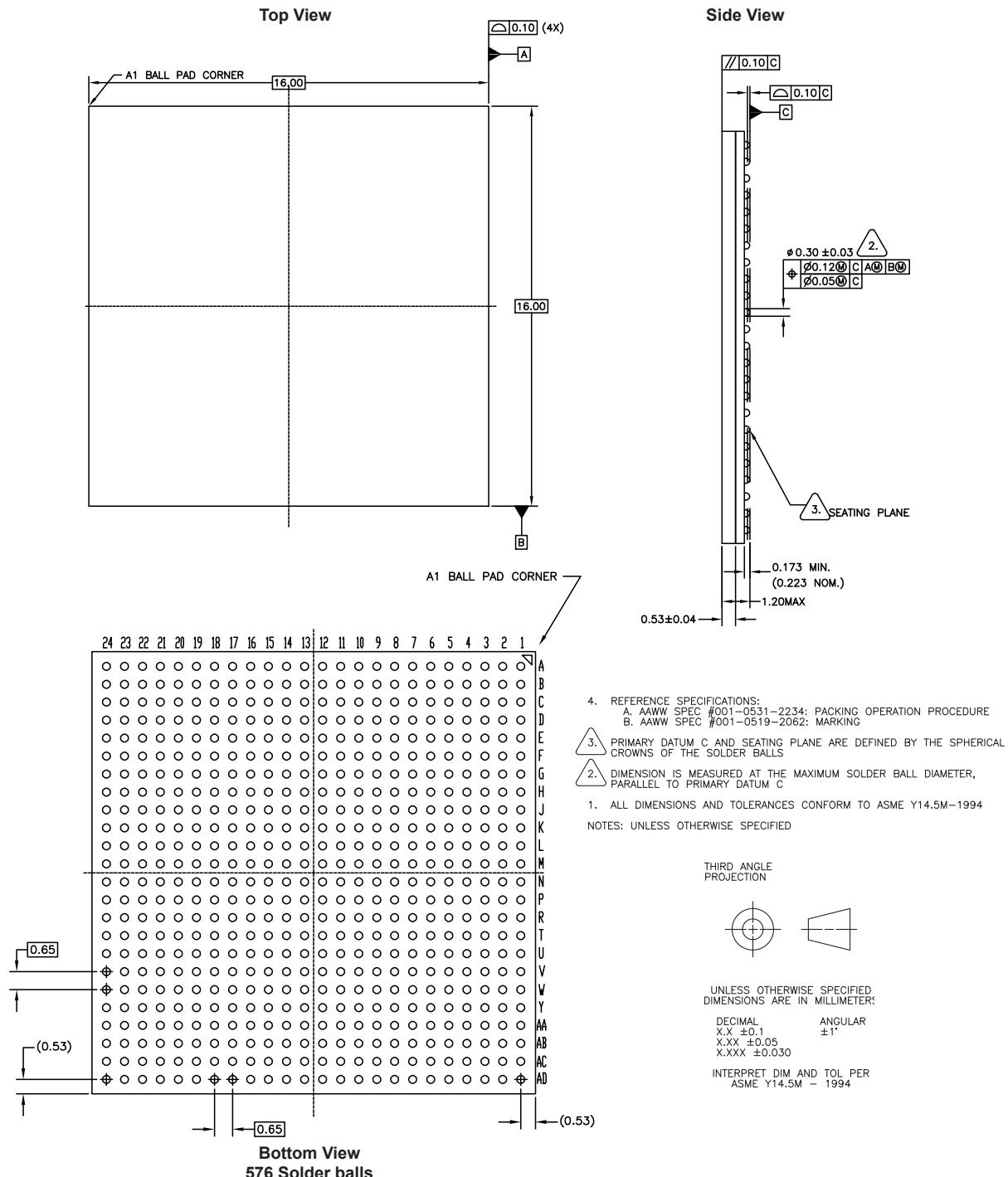
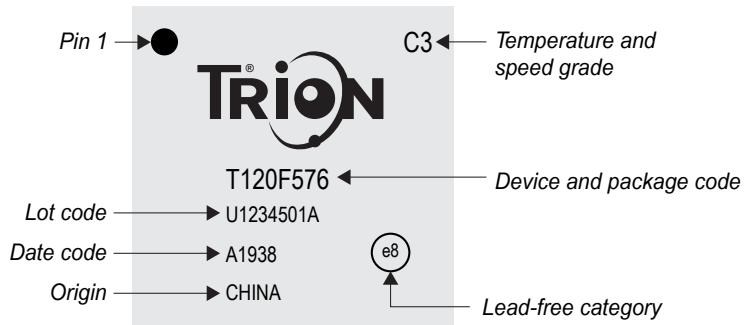


Figure 48: 576-Ball FPGA Package Marking

Solder Reflow Guidelines for Surface-Mount Devices

This section provides general guidelines for solder reflow process for Efinix® surface-mount FPGAs. The data used in this document is based on IPC/JEDEC (Association Connecting Electronics Industries/JEDEC Solid State Technology Association) standards. Each printed circuit board (PCB) has its profile, which depends upon the board design and the reflow equipment used. You must characterize each PCB to find a reliable profile.

Reflow

During solder reflow, follow these guidelines:

- Use caution when profiling to ensure that the maximum temperature difference between components is less than 10 °C.
- For best results, perform forced convection reflow with nitrogen.

Inspection

Follow these inspection guidelines:

- **Pre-reflow**—Use visual inspection to verify solder paste dispense location and quantity.
- **Pick and place**—Use machine vision as necessary to ensure proper component placement.
- **Post reflow**—Use electrical testing to verify solder joint formation.

BGA Reballing

Efinix does not recommend BGA reballing. Reballed BGA packages void the original Efinix® specifications.

Peak Reflow Temperatures

Table 8: Peak Reflow Temperature (T_p) by Package

Package	Number of Leads/Balls	Moisture Sensitivity Level	Peak Reflow Temperature (+0/-5 °C)
FBGA	49	3	260
WLCSP	80	1	260
FBGA	81	3	260
LQFP	100	3	260
FBGA	169	3	260
FBGA	256	3	260
FBGA	324	3	260
FBGA	400	3	260
FBGA	484	3	260
FBGA	576	3	260
LQFP	144	3	260



Note: These packages are "green" and RoHS compliant.

Reflow Profile for SMT Packages

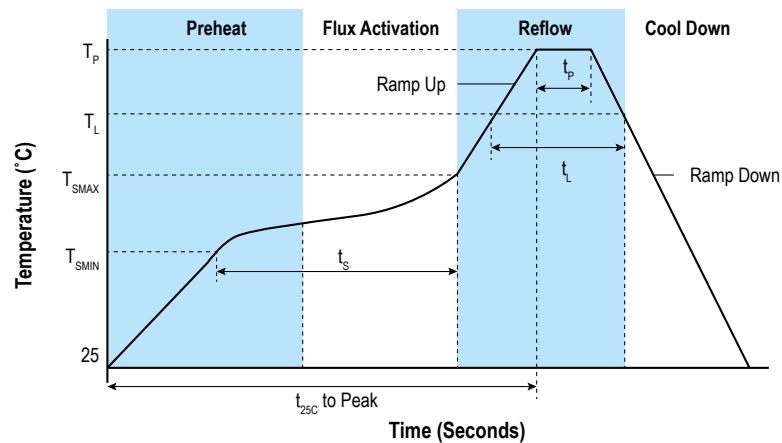
The reflow process usually includes four phases:

- 1. Preheat Phase**—The preheat phase brings the assembly from 25 °C to T_s . During this phase, the solvent evaporates from the solder paste. The preheat temperature ramp rate should be less than 2 °C/second to avoid solder balling defects such as solder ball spattering and bridging.
 - **Solder Ball Spattering**—Spattering, the most common solder balling defect, is caused by solvents evaporating explosively. To eliminate spattering, use a slower temperature rise in the preheat phase.
 - **Bridging**—Bridging is usually caused by inaccurate or splashy screen printing, and can often occur with fine pitch components. It can also be caused by solder paste slumping during a rapid temperature rise in the preheat phase.
- 2. Flux Activation Phase**—As the temperature rises slowly, it reaches a point at which the flux completely wets the surfaces to be soldered.
- 3. Reflow Phase**—The temperature rises to a level sufficient to reflow the solder. The flux wicks surface oxides and contaminants away from the melted solder, resulting in a clean solder joint.
- 4. Cool Down Phase**—Ramp down the temperature as fast as possible to control grain size; however, do not exceed 6 °C/second.

Table 9: Peak Reflow Temperature (T_p) Parameters

Parameter	Description	Specification (Lead and Halogen Free Packages)
Ramp up	Average ramp-up rate (T_{SMAX} to T_p)	3 °C/second maximum
T_{SMIN}	Preheat peak minimum temperature	150 °C
T_{SMAX}	Preheat peak maximum temperature	200 °C
t_s	Time between T_{SMIN} and T_{SMAX}	60 - 120 seconds
T_L	Solder melting point	217 °C
t_L	Time maintained above T_L	60 - 150 seconds
t_p	Time within 5 °C of peak temperature	30 seconds
Ramp down	Ramp-down rate	6 °C/second maximum
$t_{25C} \text{ to } T_p$	Time from 25 °C to peak temperature	8 minutes maximum

Figure 49: Thermal Reflow Profile



Thermal Resistance

Thermal management is an important consideration when designing your system. Efinix® device data sheets describe the maximum allowable junction temperature so you can assess your system's thermal characteristics. To ensure that the device and package do not exceed the junction temperature requirements, you should always complete a thermal analysis of your specific design.

The data shown in this section is relative and actual values depend on a variety of factors such as die size, paddle size, airflow, power applied, printed circuit board design, the proximity of other devices, and user applications. Because of this, Efinix FPGAs do not come with preset thermal solutions.

Table 10: Device/Package Thermal Resistance

Device	Package	Dimensions (mm)	Θ_{JA}/W Still Air	Θ_{JA} (200 LFM)/W	Θ_{JA} (500 LFM)/W	Θ_{JB}/W	Θ_{JC}/W
T4, T8	FBGA49	3 x 3	90.446	84.782	81.797	56.464	46.431
	FBGA81	5 x 5	80.476	75.363	72.797	55.352	32.583
T8, T20	LQFP144	20 x 20	42.82	37.68	35.50	31.12	10.51
T13, T20	LQFP100	14 x 14	51.29	45.64	43.40	37.70	15.21
	FBGA169	9 x 9	38.25	33.33	31.60	23.64	12.39
	FBGA256	13 x 13	24.24	20.52	17.59	31.57	11.85
T20	WLCSP80	4.5 x 3.5	44.94	39.35	37.54	18.91	0.12
T20, T35	FBGA324	12 x 12	20.69	17.89	16.89	10.12	2.59
	FBGA400	16 x 16	18.70	16.95	15.92	12.45	11.10
T55, T85, T120	FBGA324	12 x 12	16.9	14.4	13.5	8.04	2.01
	FBGA484	18 x 18	15.85	12.83	11.99	6.10	4.10
	FBGA576	16 x 16	15.376	13.648	12.568	6.601	1.712

Where:

- Θ_{JA} is the junction-to-ambient thermal resistance
- Θ_{JB} is the junction-to-board thermal resistance
- Θ_{JC} is the junction-to-case thermal resistance

PCB Guidelines for BGA Packages

PCB Solder Pad Guidelines

Efinix provides solder mask defined (SMD) and non-solder mask defined (NSMD) diameter information. Use this data when creating your board landing pads.

Non-solder-mask defined (NSMD) pad designs perform better than solder mask defined pads due to lower stresses in the solder near the top of pad. Additionally, they provide a better “grip” area around the pad edge. For best reliability, the Generic Requirements for Surface Mount Design and Land Pattern Standard (IPC-7351A) recommends a NSMD pad with a diameter that is slightly smaller than the solder ball.

Figure 50: SMD and Non-SMD Pad Specification

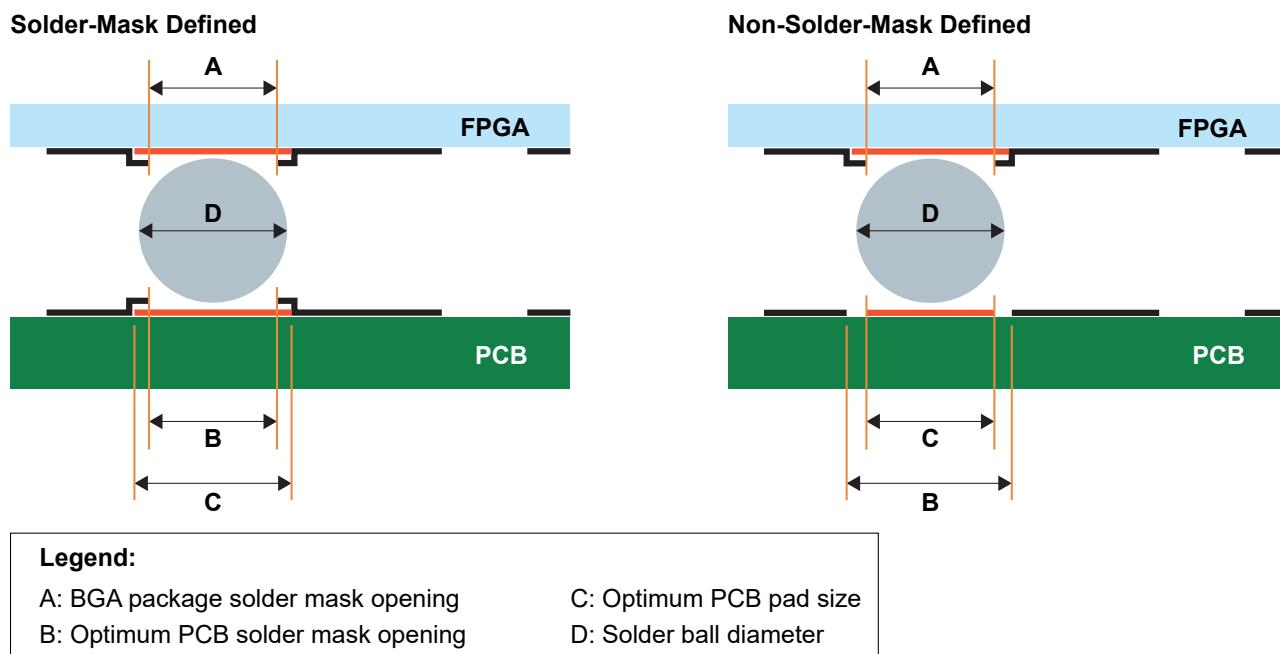


Table 11: PCB Solder Pad Recommendations

Package	Pitch (mm)	A BGA Package Solder Mask Opening (mm)	SMD		Non-SMD		D Solder Ball Diameter (mm)
			B Optimum PCB Solder Mask Opening (mm)	C Optimum PCB Pad Size (mm)	B Optimum PCB Solder Mask Opening (mm)	C Optimum PCB Pad Size (mm)	
F49	0.4	0.2	0.2	0.275	0.3	0.2	0.25
W80	0.4	N.A.	0.175	0.225	0.25	0.175	0.2
F81	0.5	0.245	0.245	0.325	0.4	0.2	0.25
F169	0.65	0.25	0.25	0.35	0.4	0.2	0.25
F256	0.8	0.37	0.37	0.5	0.5	0.35	0.4
F324 (T20, T35)	0.65	0.275	0.275	0.335	0.4	0.25	0.3
F324 (T55, T85, T120)	0.65	0.275	0.275	0.38	0.4	0.25	0.3
F400	0.8	0.275	0.275	0.38	0.4	0.25	0.3
F484	0.8	0.35	0.35	0.45	0.5	0.35	0.4
F576	0.65	0.275	0.275	0.38	0.4	0.25	0.3

Routing between Pads on the Top Layer

You can route signal trace between solder pads on the top layer of the PCB while meeting the clearance requirement.

Figure 51: Routing Traces between Pads on the Top Layer

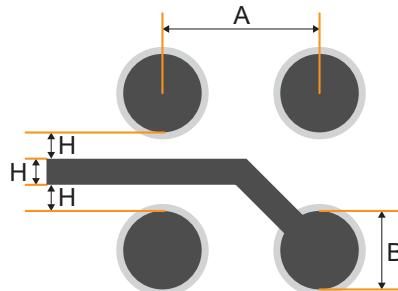


Table 12: Routing Measurements

Measure- ment	Description	Ball Count										Unit
		F49	W80	F81	F169	F256	F324 (T20, T35)	F324 (T55, T85, T120)	F400	F484	F576	
A	Ball pitch.	0.4	0.4	0.5	0.65	0.8	0.65	0.65	0.8	0.8	0.65	mm
	Ball ϕ .	0.25	0.2	0.25	0.25	0.4	0.3	0.3	0.3	0.4	0.3	mm
B	Width of the solder landing pad ϕ (SMD)	0.275	0.225	0.325	0.35	0.5	0.335	0.38	0.38	0.45	0.38	mm
	Width of the solder landing pad ϕ (NSMD)	0.2	0.175	0.2	0.2	0.35	0.25	0.25	0.25	0.35	0.25	mm
H (min.)	Minimum space between the trace and the landing pad (SMD)	(5)	(5)	0.05	0.08	0.08	0.1	0.08	0.1	0.1	0.08	mm
	Minimum space between the trace and the landing pad (NSMD)	(5)	(5)	0.08	0.1	0.1	0.1	0.1	0.1	0.1	0.1	mm

⁽⁵⁾ The via is under the pad, no traces between landing pads.

Guidelines for Vias

You use vias to drop routing down to lower layers. This type of via, called an “offset via,” is very robust. The solder mask completely covers the via, which prevents short circuits during paste application, allows for paste overprinting, and prevents etch entrapment.

PCB fabricators use a laser drill for these size vias. Confirm that your fabricator can maintain the tight tolerances required to ensure adequate clearances between vias and pads.

Figure 52: Via Dimensions

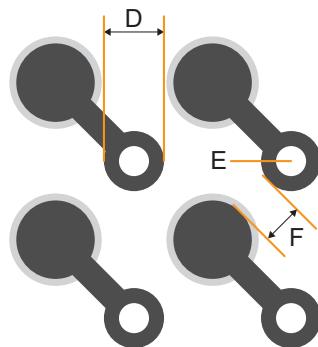


Table 13: Via Measurements

Measure- ment	Description	Ball Count										Unit
		F49	W80	F81	F169	F256	F324 (T20, T35)	F324 (T55, T85, T120)	F400	F484	F576	
D	Via capture pad width.	0.16	0.16	0.22	0.3	0.4	0.3	0.3	0.3	0.4	0.3	mm
E	Finished via ϕ .	0.1	0.1	0.13	0.15	0.25	0.15	0.2	0.2	0.25	0.2	mm
F (min.)	Space between the landing pad and via.	(6)	(6)	0.08	0.12	0.11	0.14	0.11	0.14	0.12	0.11	mm

⁽⁶⁾ The via is under the pad, no traces between landing pads.

Routing through Different PCB Layers

You can route a trace between two solder pads, at the outer two rows of solder pads on the top layer. If you use all of the top-layer routing tracks to route the first and second rows, the inner rows of solder pads must connect to another routing layer with vias for routing outside of the BGA area.

You can use this method to route all of the inner solder pads. Because there is only enough space to route one trace between vias, you need an additional routing layer for every inner row of solder pads after the fourth row.

Figure 53: BGA Trace Routing for Top and Second Layers

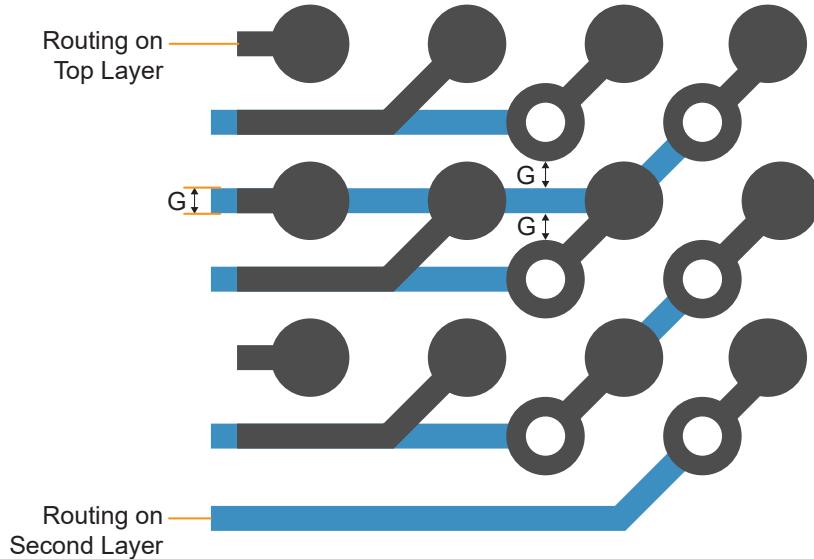


Table 14: Routing Measurements

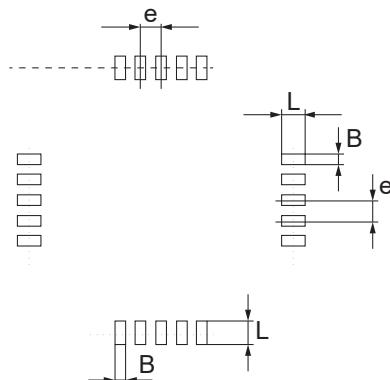
Measure- ment	Description	Ball Count										Unit
		F49	W80	F81	F169	F256	F324 (T20, T35)	F324 (T55, T85, T120)	F400	F484	F576	
G (min.)	Minimum space required between via trace and spacing.	0.08	0.08	0.085	0.01	0.1	0.1	0.1	0.1	0.1	0.1	mm

PCB Guidelines for QFP Packages

PCB Solder Pad (LQFP Packages)

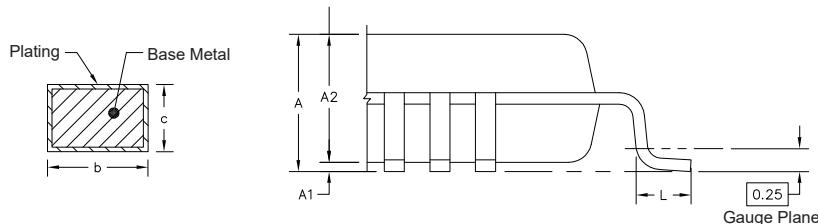
Efinix provides LQFP lead dimension information. Use this data when creating your board layout so that the board pads match the landing pads.

Figure 54: Recommended PCB Landing Pad Guideline



Package	L	B	e
LQFP 144-pin	1.35 mm	0.29 mm	0.5 BSC
LQFP 100-pin	1.35 mm	0.29 mm	0.5 BSC

Figure 55: LQFP Lead Dimensions



	Symbol	Min	Nom	Max
Total thickness	A	-	-	1.6
Stand-off	A1	0.05	-	0.15
Mold thickness	A2	1.35	1.4	1.45
Lead width	b	0.17	0.22	0.27
L/F thickness	c	0.09	-	0.2
	L	0.45	0.6	0.75

Green Packaging

Efinix FPGAs use packaging solutions that are safer for the environment. These packages are lead (Pb) free and are RoHS compliant. Efinix refers to these products as "green" packaging.

Tape and Reel Packaging

Efinix offers BGA and WLCSP devices in tape and reel packaging.

Table 15: Tape and Reel Packaging

Package	Carrier Width (mm)	Cover Width (mm)	Pitch (mm)	Reel Size (in)	Maximum Quantity per Reel
FBGA49	12	9.3	8	13	5,000
	12	9.3	8	7	1,500
FBGA81	12	9.3	8	13	5,000
	12	9.3	8	7	1,500
WLCSP80	12	9.5	8	13	2,500

Figure 56: Pin 1 Location (BGA49 and BGA81 Packages)

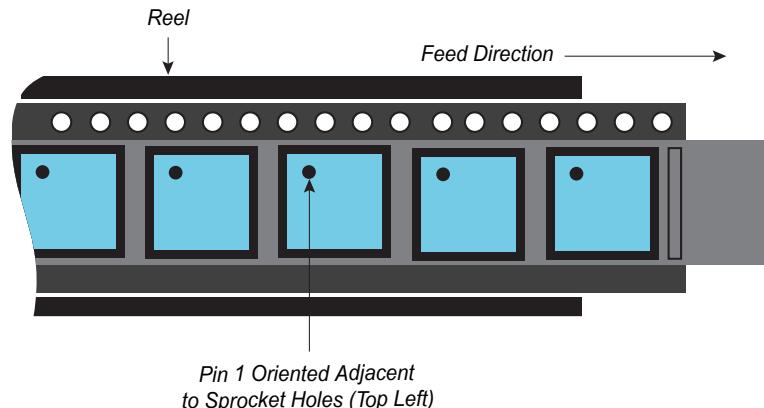
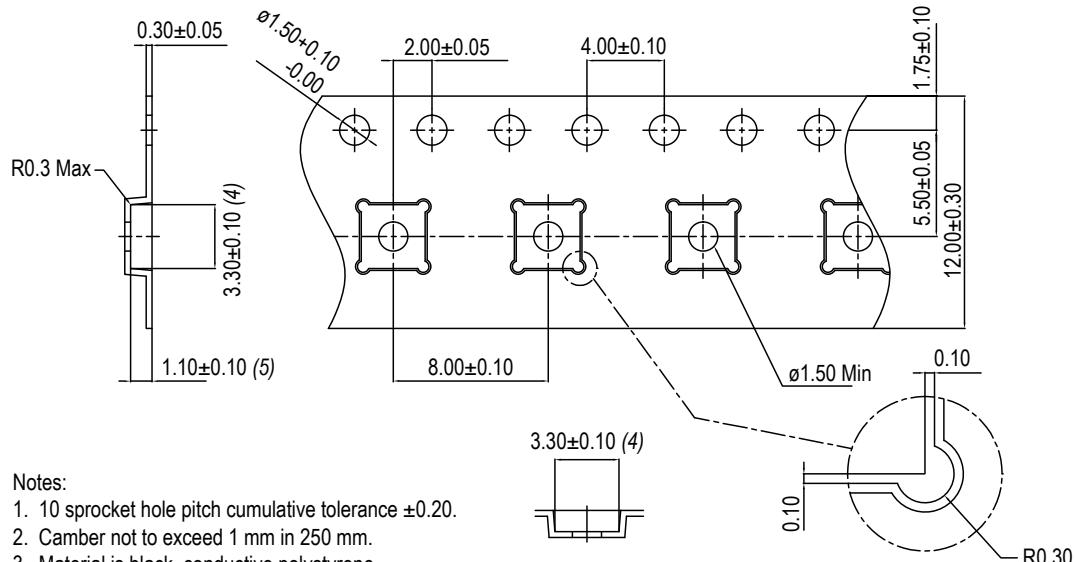


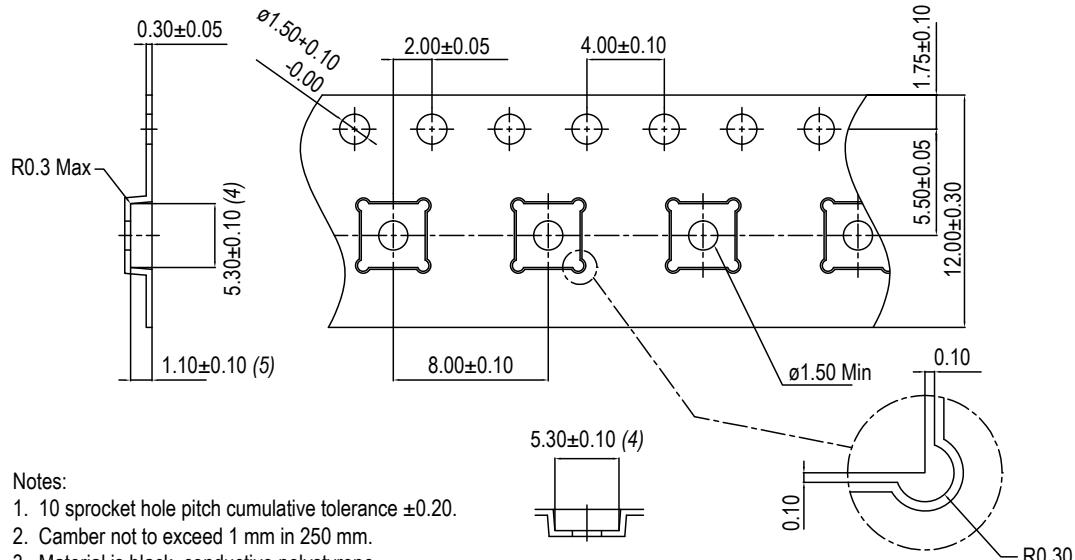
Figure 57: Tape Outline (BGA49 Packages)



Notes:

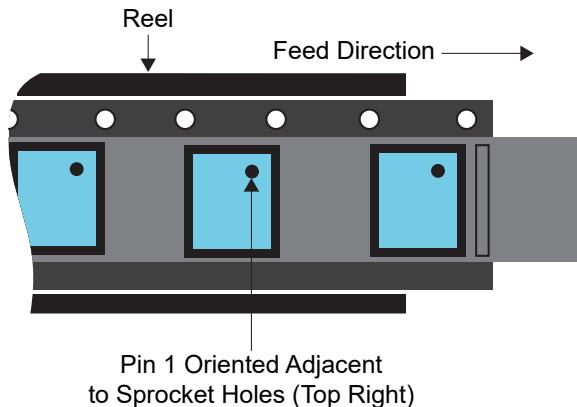
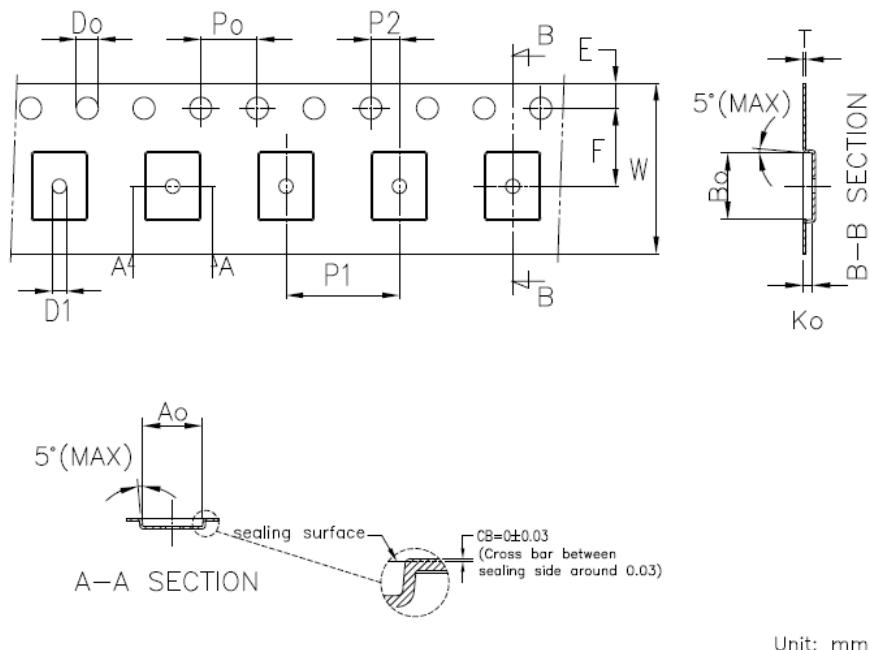
1. 10 sprocket hole pitch cumulative tolerance ± 0.20 .
2. Camber not to exceed 1 mm in 250 mm.
3. Material is black, conductive polystyrene.
4. Measured on a plane 0.3 mm above the bottom of the pocket.
5. Measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.
7. Pocket center and pocket hole center must be the same position.

Figure 58: Tape Outline (BGA81 Packages)



Notes:

1. 10 sprocket hole pitch cumulative tolerance ± 0.20 .
2. Camber not to exceed 1 mm in 250 mm.
3. Material is black, conductive polystyrene.
4. Measured on a plane 0.3 mm above the bottom of the pocket.
5. Measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.
7. Pocket center and pocket hole center must be the same position.

Figure 59: Pin 1 Location (WLCSP80 Packages)**Figure 60: Tape Outline (WLCSP80 Packages)**

Symbol	Ao	Bo	Ko	Po	P1	P2	T
Spec	3.76 ± 0.05	4.66 ± 0.05	0.66 ± 0.05	4.00 ± 0.10	8.00 ± 0.10	2.00 ± 0.05	0.25 ± 0.03
Symbol	E	F	Do	D1	W	$10Po$	
Spec	1.75 ± 0.10	5.50 ± 0.05	$1.50^{+0.10}_{-0}$	1.00 ± 0.05	12.0 ± 0.30	40.0 ± 0.20	

Notice:

1. 10 Sprocket hole pitch cumulative tolerance is $\pm 0.20\text{mm}$.
2. Carrier camber shall be not more than 1mm per 250mm.
3. Ao & Bo measured on a place in the middle of corner radii.
4. Ko measured from a place on the inside bottom of the pocket to top surface of carrier.
5. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.
6. Surface resistivity $\geq 1.0 \times 10^5$ & $\leq 1.0 \times 10^8 \text{ ohm/sq}$.

Tray Packaging

Efinix offers BGA and LQFP devices in tray packaging.

Table 16: Tray Packaging

Package	Quantity per Tray	Tray Matrix	Tray Stack	Minimum Quantity per Stack
FBGA256	119	7 x 17	10 + 1	1,190
FBGA169	260	10 x 26	10 + 1	2,600
LQFP100	90	6 x 15	10 + 1	900
LQFP144	60	12 x 5	10 + 1	600
FBGA324	168	21 x 8	10 + 1	1,680
FBGA400	84	14 x 6	10 + 1	840
FBGA484	84	14 x 6	10 + 1	840
FBGA576	84	14 x 6	10 + 1	840

Revision History

Table 17: Revision History

Date	Version	Description
September 2023	4.9	Updated CCK pin description. (DOC-1451)
August 2023	4.8	Updated package outline for 49-Ball and 576-Ball FBGA Package Specifications. Added in package thickness of 1.07mm for 324-Ball Package Specifications. (ADV-2307-001) (DOC-1350)
June 2023	4.7	Updated Trion T13/T20 Q100F3. (DOC-1164)
February 2023	4.6	Corrected side view dimensions for F256 package. (DOC-813) Corrected routing and via dimensions for the F169 package. (DOC-804) Added 1,500 quantity tape and reel information for T4 and T8 FPGAs in BGA49 and BGA81 packages. Added PCB data for F400 packages. (DOC-928) Updated routing measurements. (DOC-928)
April 2022	4.5	Corrected typo for pin A9 in BGA400 package pinout and I/O banks. (DOC-784)
March 2022	4.4	Corrected typos for pins G6 and H15 in BGA400 package pinout and I/O banks. (DOC-756) Noted that BGA324, BGA400, and BGA576 are flip-chip packages. (DOC-756)
March 2022	4.3	Removed thermal pad from LQFP144 Recommended PCB Landing Pad Guideline; this package does not have a thermal pad. (DOC-751)
February 2022	4.2	Fixed typo in LQFP144 package pinout and I/O banks. Pin 31 was incorrectly marked as 34.
February 2022	4.1	Added recommended PCB landing pad guideline for LQFP packages. Corrected color coding for VCCIO4A in the BGA169 I/O bank diagram. (DOC-719) Correct the F (min.) via measurement for the BGA484 and BGA256 packages. (DOC-710)
December 2021	4.0	Fix incorrect pin names for T55/T85/T120 FPGAs in the BGA324 package. (DOC-671)
November 2021	3.9	Fixed incorrect color coding for I/O banks VCCIO_1F_1G in the BGA484 package. (DOC-639)
November 2021	3.8	Corrected symbols for pins L19 and R15 for the 400 BGA package. (DOC-564)
August 2021	3.7	Corrected pin numbering for the WLCSP80 package. (DOC-504) Corrected pitch for F576 in the PCB Solder Pad Recommendations table. (DOC-504) Updated PCB solder pad recommendations (DOC-504) Corrected pin A9 for F256 package pinout. (DOC-493)
July 2021	3.6	Rotated package outline, pinout, and I/O banks figures for the WLCSP80 to make it easier to identify pin 1.

Date	Version	Description
June 2021	3.5	Added thermal resistance data for WLCSP80 package. (DOC-439) Added tape and reel information for WLCSP80. (DOC-439) Added peak reflow temperature for WLCSP80. Corrected typos in BGA256 pinout and fixed mislabeled banks in BGA256 I/O banks. (DOC-452)
December 2020	3.4	Added WLCSP80 package information.
August 2020	3.3	Updated routing measurements and via measurements.
July 2020	3.2	Corrected the BGA169 pinout.
July 2020	3.1	Updated solder ball co-planarity limit from 0.1 to 0.15. Updated 81-ball FPGA package marking.
May 2020	3.0	Added guidelines for traces, pads, and vias for PCB design. Added BGA400 package information. Updated side view BGA576 package dimensions.
February 2020	2.1	Fixed typos in BGA576 pinout and I/O bank diagrams.
January 2020	2.0	Added BGA324, BGA484, and BGA576 package information.
October 2019	1.6	Added LQFP144 package information.
August 2019	1.5	Updated BGA169 and BGA256 package marking.
June 2019	1.4	Added 169 ball FBGA package information.
February 2019	1.3	Added Thermal resistance, solder pad dimensions, and peak reflow data for the 256 BGA package. Added information on tray packaging. Clarified PLL ground pin in the 81 ball BGA diagram and pinout. Updated 256 ball FBGA package marking.
November 2018	1.2	Added 256 ball FBGA package information.
August 2018	1.1	Updated BGA81 pin figure.
July 2018	1.0	Initial release.